

BLANK PAGE



Indian Standard

SAMPLING PLANS AND PROCEDURES FOR INSPECTION BY ATTRIBUTES FOR ELECTRONIC ITEMS

UDG 621-30-638 : 519-245-33



© Copyright 1984

INDIAN STANDARDS INSTITUTION
MANAK BHAVAN, S RAHADUR SHAH ZAFAR MARG
NEW DELHI 110002

Indian Standard

SAMPLING PLANS AND PROCEDURES FOR INSPECTION BY ATTRIBUTES FOR **ELECTRONIC ITEMS**

Reliability of Electronic and Electrical Components and Equipment Sectional Committee, LTDC 3

Chairman

PROF S. SAMPATH Indian Institute of Technology, Kanpur

Members

Representing

ADDITIONAL DIRECTOR, STANDARDS (S & T), Railway Board (Ministry of Railways) RDSO

JOINT DIRECTOR, STANDARDS (S & T)-III,

RDSO (Alternate) Dr K. Chandra

SHRI CHARANJIT SINGH
SQN-LDR I. M. GANDOTRA (Alternate)

CONTROLLER, CIL LT-Col V. K. KHANNA (Alternate)

DR P. K. DUTTA

Shri V. Narayanan (Alternate)

Shri B. P. Ghosh

SHRI B. C. MUKHERJEE (Alternate)

SHRI A. P. GUPTA SHRI I. S. SULAKH (Alternate)

SHRI S. P. KULKARNI

SHRI S. M. KHURSALE (Alternate)

SHRI H. C. MATHUR SHRI U. R. G. ACHARYA (Alternate)

SHRI D. C. MEHTA

SHRI R. V. ISRANI (Alternate)

SHRI S. R. MEHTA

SHRI T. C. GOSALIA (Alternate)

DR K. B. MISRA

SHRI E. G. NAGARAJAN

Shri K. R. Anandakumaran Nair

SHRI C. RANGANATHAN (Alternate)

SHRI D. V. PETKAR

SHRI A. K. BABAR (Alternate)
SHRI V. B. PRADHAN

SHRI N. J. NAIR (Alternate) SHRI P. S. K. PRASAD SHRI K. RAMGOPAL

SHRI SIHARAN DE (Alternate)

SHRI K. S. PRAKASA RAO

SHRI S. S. SONWALKAR (Alternate)

SHRI R. SOMASUNDARAM

SHRI R. N. SHARMA (Alternate)

COL J. VARGHESE

SHRI P. K. SHUKLA (Alternate)

SHRI B. VIRESALINGAM

SHRI V. MUTHAIAH (Alternate)

SHRI R. C. JAIN,

Head (Electronics) (Secretary)

National Physical Laboratory (CSIR), New Delhi

Hindustan Aeronautics Ltd, Hyderabad Ministry of Defence (DGI)

Peico Electronics and Electricals Ltd, Bombay

National Test House, Calcutta

Instrumentation Ltd, Kota

The Radio Electronic & Television Manufacturers' Association,

Bombay

Posts and Telegraphs Board, New Delhi

Directorate General of Civil Aviation, New Delhi

Indian Electrical Manufacturers' Association, Bombay

personal capacity (Department of Electrical Engineering, Indian

Institute of Technology, Kharagpur)

Department of Electronics, New Delhi

Lucas-TVS Ltd, Madras

Bhabha Atomic Research Centre, Trombay, Bombay

All India Radio, New Delhi

Bharat Electronics Ltd, Bangalore

ISRO Satellite Centre (ISAC), Bangalore

Electronics Corporation of India Ltd, Hyderabad

Directorate of Technical Development and Production (AIR),

Ministry of Defence

Ministry of Defence (R & D)

Indian Telephone Industries Ltd, Bangalore

Director General, ISI (Ex-officio Member)

(Continued on page 2)

© Copyright 1984

INDIAN STANDARDS INSTITUTION

This publication is protected under the Indian Copyright Act (XIV of 1957) and reproduction in whole or in part by any means except with written permission of the publisher shall be deemed to be an infringement of copyright under the said Act.

IS: 10673 - 1983

(Continued from page 1)

Study of Statistical Problems of Reliability of Electronic and Electrical Items Subcommittee, LTDC 3:1

Convener

DR P. K. DUTTA

Members

LT-COL V. K. KHANNA MAJ S. P. MURGAI (Alternate)

MAJ S. P. MURGAI (Alternate)
SHRI V. NARAYANA
SHRI P. S. K. PRASAD
SHRI K. RAMGOPAL
DR Y. V. SOMAYAJULU
SHRI V. N. SHARMA (Alternate)
COL J. VARGHESE
SHRI P. K. SHUKLA (Alternate)

Representing

Peico Electronics & Electricals Ltd, Bombay

Ministry of Defence (DGI)

Indian Statistical Institute, Hyderabad Bharat Electronics Ltd, Bangalore
ISRO Satellite Centre (ISAC), Bangalore
Nationa! Physical Laboratory (CSIR), New Delhi

Ministry of Defence (R & D)

CONTENTS

		PAGE
0.	Foreword	5
1.	Scope	5
2.	Application	5
3.	General	6
4.	Acceptable Quality Level (AQL)	6
5.	Submission of Product	7
6.	Acceptance and Rejection	7
7.	Drawing of Samples	8
8.	NORMAL, TIGHTENED AND REDUCED INSPECTION	8
9.	SAMPLING PLANS	8
10.	DETERMINATION OF ACCEPTABILITY	9
11.	Supplementary Information	9
TAB	DLES	
1	Sample Size Code Letters	11
2A	Single Sampling Plans for Normal Inspection ($f M$ aster Table)	12
2B	SINGLE SAMPLING PLANS FOR TIGHTENED INSPECTION (MASTER TABLE)	13
2C	SINGLE SAMPLING PLANS FOR REDUCED INSPECTION (MASTER TABLE)	14
3A	Double Sampling Plans for Normal Inspection (Master Table)	15
3B	Double Sampling Plans for Tightened Inspection (Master Table)	16
3C	DOUBLE SAMPLING PLANS FOR REDUCED INSPECTION (Master Table)	17
4 A	Multiple Sampling Plans for Normal Inspection (Master Table)	18
4 B	Multiple Sampling Plans for Tightened Inspection (Master Table)	20
4C	Multiple Sampling Plans for Reduced Inspection (Master Table)	22
5 A	AVERAGE OUTGOING QUALITY LIMIT FACTORS FOR NORMAL INSPECTION (SINGLE SAMPLING)	24
5B		25
6A		26
6B	Limiting Quality (in Defects Per Hundred Units) for Which $P_{\rm a}=10$ Percent (for Normal Inspection, Single Sampling)	27
7A	Limiting Quality (in Percent Defective) for Which $P_a = 5$ Percent (for Normal Inspection, Single Sampling)	28

IS: 10673 - 1983

					PAGE
7B	Limiting Quality (in Defects : for Which $P_a=5$ Percent (fo Single Sampling)	Per Hun r Norma	dred Ui L Inspec	NITS) TION,	29
8	LIMIT NUMBERS FOR REDUCED INSP	ECTION			30
9	Average Sample Size Curves for Sampling (Normal and Tighteni			TIPLE	31
	Sampling Plans and Operating (and Data) for :	CHARACTE	RISTIC C	JRVES	
10A	Sample Size Code Letter A	•••	•••	•••	32
10 B	Sample Size Code Letter B		•••	•••	34
10 C	Sample Size Code Letter C	•••	•••	•••	36
10 D	Sample Size Code Letter D	•••	•••	•••	38
10 E	Sample Size Code Letter E	•••	•••	•••	40
10F	Sample Size Code Letter F	•••	•••	•••	42
10G	Sample Size Code Letter G		•••		44
10 H	Sample Size Code Letter H		•••	•••	46
10J	Sample Size Code Letter J	•••	•••	•••	48
10 K	Sample Size Code Letter K	•••	•••	•••	50
10 L	Sample Size Code Letter L	•••	•••	•••	52
10M	I Sample Size Code Letter M	•••	•••	•••	54
10N	SAMPLE SIZE CODE LETTER N	•••	•••	•••	56
10 P	SAMPLE SIZE CODE LETTER P		•••	•••	58
10Q	Sample Size Code Letter Q	•••	•••	•••	60
10R	SAMPLE SIZE CODE LETTER R	•••	•••	•••	62
10S	Sample Size Code Letter S	•••	•••	•••	64
A	Table of Tab	3.6-			~ =

Indian Standard

SAMPLING PLANS AND PROCEDURES FOR INSPECTION BY ATTRIBUTES FOR ELECTRONIC ITEMS

0. FOREWORD

- **0.1** This Indian Standard was adopted by the Indian Standards Institution on 26 September, 1983, after the draft finalized by the Reliability of Electronic and Electrical Components and Equipment Sectional Committee had been approved by the Electronics and Telecommunication Division Council.
- **0.2** This standard provides the tables from which sampling plans can be selected for inspection by attributes. All the plans given in this standard require that the lot quality should be specified in terms of fraction (or percentage) defective. The plans are sufficiently flexible to meet a wide variety of quality requirements and administrative and technical conditions.
- 0.3 The electronic industry world-over have been using MIL-STD-105 'Military Standard on sampling procedures and tables for inspection by attributes' brought out by Department of Defence, USA; particularly its 1963 version has been accepted in toto in IEC Standard 410 'Sampling plans and procedures for inspection by attributes for electronic items' brought out by International Electrotechnical Commission and in 1SO 2859 'Sampling procedures and tables for inspection by attributes' brought out by International Organization for Standardization, not only for electronic items but also for all other products.
- **0.4** The differences between the ISO/IEC standard and IS: 2500 (Part 1)-1973* relate to the batch sizes, switching rules, sampling plans and procedures for tightened inspection and reduced inspection in addition to lower

- AQLs and special inspection levels which are required for electronic items. As it has not been found practicable to reconcile the basic differences, Reliability of Electronic and Electrical Components and Equipment Sectional Committee decided that a separate standard, based on IEC Publication 410 to deal with the sampling plans and procedures for electronic items, should be published. The position of this standard may be reviewed at the time of revision of IS: 2500 (Part 1)-1973*.
- **0.5** With a view to facilitating reference to this standard, an index of terms with special meanings is given in Appendix A.
- **0.6** This standard is largely based on IEC Publication 410 (1973) 'Sampling plans and procedures for inspection by attributes' issued by the International Electrotechnical Commission (IEC).
- **0.7** This standard is one of a series of Indian Standards on reliability of electronic and electrical components and equipment. A list of standards published so far in this series is given on page 66.
- **0.8** For the purpose of deciding whether a particular requirement of this standard is complied with, the final value, observed or calculated, expressing the result of a test, shall be rounded off in accordance with IS: 2-1960†. The number of significant places retained in the rounded off value should be the same as that of the specified value in this standard.

†Rules for rounding off numerical values (revised).

1. SCOPE

1.1 This standard covers sampling plans and procedures for inspection by attributes for electronic items.

NOTE — When specified by the responsible authority, this standard shall be called up in the specification, contract, inspection instructions or other documents and the provisions set forth herein shall govern. The 'responsible authority' shall be designated in one of the above documents. The responsible authority may be the customer.

2. APPLICATION

- **2.1** Sampling plans designated in this standard are applicable, but not limited, to inspection of the following:
 - a) End items,
 - b) Components and raw materials,
 - c) Operations,
 - d) Materials in process,

^{*}Sampling inspection tables: Part 1 Inspection by attributes and by count of defects (first revision).

- e) Supplies in storage,
- f) Maintenance operations,
- g) Data or records, and
- h) Administrative procedures.
- 2.1.1 These plans are intended primarily to be used for a continuing series of lots or batches. The plans may also be used for the inspection of isolated lots or batches, but in this latter case, the user is cautioned to consult the operating characteristic curves to find a plan which will yield the desired protection (see 11.6).

3. GENERAL

- **3.1 Inspection** Inspection is the process of measuring, examining, testing or otherwise comparing the unit of product (see 3.3) with the requirements.
- 3.2 Inspection by Attributes Inspection whereby either the unit of product is classified simply as defective or non-defective or the number of defects in the unit of product is counted, with respect to a given requirement or set of requirements.
- 3.3 Unit of Product The thing inspected in order to determine its classification as defective or non-defective or to count the number of defects. It may be a single article, a pair, a set, a length, an area, an operation, a volume, a component of an end product, or the end product itself. The unit of product may or may not be the same as the unit of purchase, supply, production or shipment.

3.4 Classification of Defects and Defectives

3.4.1 Method of Classifying Defects — A classification of defects is the enumeration of possible defects of the unit of product classified according to their seriousness. A defect is any non-conformance of the unit of product to specified requirements.

Defects will normally be grouped into one or more of the classes specified in **3.4.1.1** to **3.4.1.3**, however, defects may be grouped into other classes, or into sub-classes within these classes.

3.4.1.1 Critical defect — A critical defect is a defect that judgment and experience indicate, is likely to result in hazardous or unsafe conditions for individuals using, maintaining or depending upon the product; or a defect that judgment and experience indicate, is likely to prevent performance of the function of a major end item such as a ship, aircraft, computer, medical equipment or telecommunication satellite.

Note — For a special provision relating to critical defects, see 6.3.

- **3.4.1.2** Major defect A major defect is a defect, other than critical, that is likely to result in failure, or to reduce materially the usability of the unit of product for its intended purpose.
- **3.4.1.3** Minor defect A minor defect is a defect that is not likely to reduce materially the usability of the unit of product for its intended purpose, or is a departure from established standards having little bearing on the effective use or operation of the unit.
- **3.4.2** Method of Classifying Defectives A defective is a unit of product which contains one or more defects. Defectives will usually be classified as follows.
- 3.4.2.1 Critical defective A critical defective contains one or more critical defects and may also contain major and/or minor defects.

Note — For a special provision relating to critical defectives, see 6.3.

- **3.4.2.2** Major defective A major defective contains one or more major defects and may also contain minor defects but contains no critical defect.
- **3.4.2.3** Minor defective A minor defective contains one or more minor defects but contains neither critical nor major defect.

3.5 Percent Defective and Defects per Hundred Units

- **3.5.1** Expression of Non-conformance The extent of non-conformance of product shall be expressed either in terms of percent defective or in terms of defects per hundred units.
- **3.5.2** Percent Defective The percent defective of any given quantity of units of product is one hundred times the number of defective units of product contained therein divided by the total number of units of product, that is:

 $\frac{\text{Percent}}{\text{defective}} = \frac{\text{Number of defectives}}{\text{Number of units inspected}} \times 100$

3.5.3 Defects Per Hundred Units — The number of defects per hundred units of any given quantity of units of product is one hundred times the number of defects contained therein (one or more defects being possible in any unit of product) divided by the total number of units of product, that is:

Defects per hundred units = $\frac{\text{Number of defects}}{\text{Number of units inspected}} \times 100$

4. ACCEPTABLE QUALITY LEVEL (AQL)

4.1 Use — The AQL, together with the sample size code letter, is used for indexing the sampling plans provided herein.

- 4.2 Acceptable Quality Level (AQL)—The AQL is the maximum percent defective (or the maximum number of defects per hundred units) that, for purposes of sampling inspections, can be considered satisfactory as a process average (see 11.2).
- 4.3 Note on the Meaning of AQL When a consumer designates some specific value of AQL for a certain defect or group of defects, he indicates to the supplier that his (the consumer's) acceptance sampling plan will accept the great majority of the lots or batches that the supplier submits, provided the process average level of percent defective (or defects per hundred units) in these lots or batches be no greater than the designated value of AQL. Thus, the AQL is a designated value of percent defective (or defects per hundred units) that the consumer indicates will be accepted most of the time by the acceptance sampling procedure to be used. The sampling plans provided herein are so arranged that the probability of acceptance at the designated AQL value depends upon the sample size, being generally higher for large samples than for small ones, for a given AQL. The AQL alone does not describe the protection to the consumer for individual lots or batches but more directly relates to what might be expected from a series of lots or batches, provided the steps indicated in this standard are taken. It is necessary to refer to the operating characteristic curve of the plan, to determine what protection the consumer will have.
- **4.4 Limitation** The designation of an AQL shall not imply that the supplier has the right to supply knowingly any defective unit of product.
- 4.5 Specifying AQLs The AQL to be used will be designated in the contract or by the responsible authority. Different AQLs may be designated for groups of defects considered collectively, or for individual defects. An AQL for a group of defects may be designated in addition to AQLs for individual defects, or sub-groups, within that group. AQL values of 10 or less may be expressed either in percent defective or in defects per hundred units; those over 10 shall be expressed in defects per hundred units only.
- **4.6 Preferred AQLs** The values of AQLs given in these tables are known as preferred AQLs. If, for any product, an AQL be designated other than a preferred AQL, these tables are not applicable.

5. SUBMISSION OF PRODUCT

5.1 Lot or Batch — The term 'lot' or 'batch' shall mean 'inspection batch', that is, a collection of units of product from which a sample is to

- be drawn and inspected to determine conformance with the acceptability criteria, and may differ from a collection of units designated as a lot or batch for other purposes (for example, production, shipment, etc).
- **5.2 Formation of Lots or Batches** The product shall be assembled into identifiable lots, sub-lots, batches, or in such other manner as may be prescribed (see **5.4**). Each lot or batch shall, as far as is practicable, consist of units of product of a single type, grade, class, size and composition, manufactured under essentially the same conditions and at essentially the same time.
- **5.3 Lot or Batch Size** The lot or batch size is the number of units of product in a lot or batch.
- 5.4 Presentation of Lots or Batches The formation of lots or batches, lot or batch size, and the manner in which each lot or batch is to be presented and identified by the supplier shall be designated or approved by the responsible authority. As necessary, the supplier shall provide adequate and suitable storage space for each lot or batch, equipment needed for proper identification and presentation, and personnel for all handling of product required for drawing of samples.

6. ACCEPTANCE AND REJECTION

- 6.1 Acceptability of Lots or Batches—Acceptability of a lot or batch will be determined by the use of a sampling plan or plans associated with the designated AQL or AQLs.
- **6.2 Defective Units** The right is reserved to reject any unit of product found defective during inspection whether that unit of product forms part of a sample or not, and whether the lot or batch as a whole is accepted or rejected. Rejected units may be repaired or corrected and resubmitted for inspection with the approval of, and in the manner specified by, the responsible authority.
- 6.3 Special Reservation for Critical Defects The supplier may be required at the discretion of the responsible authority to inspect every unit of the lot or batch for critical defects. The right is reserved to inspect every unit submitted by the supplier for critical defects, and to reject the lot or batch immediately, when a critical defect is found. The right is reserved also to sample, for critical defects, every lot or batch submitted by the supplier and to reject any lot or batch if a sample drawn therefrom is found to contain one or more critical defects.
- **6.4 Resubmitted Lots or Batches** Lots or batches found unacceptable shall be resubmitted for reinspection only after all units are re-examined or retested and all defective units

are removed or defects corrected. The responsible authority shall determine whether normal or tightened inspection shall be used, and whether reinspection shall include all types or classes of defects or only the particular types or classes of defects which caused initial rejection.

7. DRAWING OF SAMPLES

- 7.1 Sample A sample consists of one or more units of product drawn from a lot or batch, the units of the sample being selected at random without regard to their quality. The number of units of product in the sample is the sample size.
- 7.2 Representative Sampling When appropriate, the number of units in the sample shall be selected in proportion to the size of the sub-lots or sub-batches, or parts of the lot or batch, identified by some rational criterion. When representative sampling is used, the units from each part of the lot or batch shall be selected at random.
- **7.3 Time of Sampling** Samples may be drawn after all the units comprising the lot or batch have been assembled, or samples may be drawn during assembly of the lot or batch.
- **7.4 Double or Multiple Sampling** When double or multiple sampling is to be used, each sample shall be selected over the entire lot or batch.

8. NORMAL, TIGHTENED AND REDUCED INSPECTION

- **8.1 Initiation of Inspection** Normal inspection will be used at the start of inspection unless otherwise directed by the responsible authority.
- 8.2 Continuation of Inspection Normal, tightened or reduced inspection shall continue unchanged for each class of defects or defectives on successive lots or batches except where the switching procedures given below require a change. The switching procedures shall be applied to each class of defects or defectives independently.

8.3 Switching Procedures

- **8.3.1** Normal to Tightened When normal inspection is in effect, tightened inspection shall be instituted when 2 out of 5 consecutive lots or batches have been rejected on original inspection (that is, ignoring resubmitted lots or batches for this procedure).
- **8.3.2** Tightened to Normal When tightened inspection is in effect, normal inspection shall be instituted when 5 consecutive lots or batches have been considered acceptable on original inspection.

- **8.3.3** Normal to Reduced When normal inspection is in effect, reduced inspection shall be instituted provided that all of the following conditions are satisfied:
 - a) The preceding 10 lots or batches (or more, as indicated by the note under Table 8) have been submitted to normal inspection and none has been rejected on original inspection.
 - b) The total number of defectives (or defects) in the samples from the preceding 10 lots or batches [or such other number as was used for condition (a) above] is equal to or less than the applicable number given in Table 8. If double or multiple sampling is in use, all samples inspected should be included, not 'first' samples only.
 - c) Production is at a steady rate.
 - d) Reduced inspection is considered desirable by the responsible authority.
- **8.3.4** Reduced to Normal When reduced inspection is in effect, normal inspection shall be instituted if any of the following occur on original inspection:
 - a) A lot or batch is rejected,
 - b) A lot or batch is considered acceptable under the procedures of **10.1.4**,
 - c) Production becomes irregular or delayed, and
 - d) Other conditions warrant that normal inspection shall be instituted.
- **8.4 Discontinuation** of Inspection In the event that 10 consecutive lots or batches remain on tightened inspection (or such other number as may be designated by the responsible authority), inspection under the provisions of this document should be discontinued pending action to improve the quality of submitted material.

9. SAMPLING PLANS

- 9.1 Sampling Plan A sampling plan indicates the number of units of product from each lot or batch which are to be inspected (sample size or series of sample sizes) and the criteria for determining the acceptability of the lot or batch (acceptance and rejection numbers).
- 9.2 Inspection Level The inspection level determines the relationship between the lot or batch size and the sample size. The inspection level to be used for any particular requirement will be prescribed by the responsible authority. Three inspection levels, I, II and III, are given in Table 1 for general use. Unless otherwise specified, Inspection Level II will be used. However, Inspection Level I may be

specified when less determination is needed, or Level III may be specified for greater discrimination. Four additional special levels, S-1, S-2, S-3, and S-4 are given in the same table and may be used where relatively small sample sizes are necessary and large sampling risks may or shall be tolerated.

NOTE — In the designation of inspection levels S-1 to S-4, care shall be exercised to avoid AQLs inconsistent with these inspection levels.

- **9.3 Code Letters** Sample sizes are designated by code letters. Table 1 shall be used to find the applicable code letter for the particular lot or batch size and the prescribed inspection level.
- 9.4 Obtaining Sampling Plan The AQL and the code letter shall be used to obtain the sampling plan from Tables 2, 3 or 4. When no sampling plan is available for a given combination of AQL and code letter, the tables direct the user to a different letter. sample size to be used is given by the new code letter, not by the original letter. If this procedure leads to different sample sizes for different classes of defects, the code letter corresponding to the largest sample size derived may be used for all classes of defects when designated or approved by the responsible authority. As an alternative to a single sampling plan with an acceptance number of 0, the plan with an acceptance number of 1, with its correspondingly larger sample size for a designated AQL (where available), may be used when designated or approved by the responsible authority.
- 9.5 Types of Sampling Plans Three types of sampling plans (single, double and multiple) are given in Tables 2, 3 and 4, respectively. When several types of plans are available for a given AQL and code letter, any one may be used. A decision as to type of plan, either single, double or multiple, when available for a given AQL and code letter, will usually be based upon the comparison between the administrative difficulty and the average sample sizes of the available plans. The average sample size of multiple plans is less than for double (except in the case corresponding to single acceptance number 1) and both of these are always less than a single sample size. Usually, the administrative difficulty for single sampling and the cost per unit of the sample are less than for double or multiple.

10. DETERMINATION OF ACCEPTABILITY

10.1 Percent Defective Inspection — To determine acceptability of a lot or batch under percent defective inspection, the applicable sampling plan shall be used in accordance with 10.1.1, 10.1.2, 10.1.3 and 10.1.4.

- 10.1.1 Single Sampling Plan The number of sample units inspected shall be equal to the sample size given by the plan. If the number of defectives found in the sample is equal to or less than the acceptance number, the lot or batch shall be considered acceptable. If the number of defectives is equal to or greater than the rejection number, the lot or batch shall be rejected.
- 10.1.2 Double Sampling Plan The number of sample units inspected shall be equal to the first sample size given by the plan. If the number of defectives found in the first sample is equal to or less than the first acceptance number, the lot or batch shall be considered acceptable. If the number of defectives found in the first sample is equal to or greater than the first rejection number, the lot or batch shall be rejected. If the number of defectives found in the first sample is between the first acceptance and rejection numbers, a second sample of the size given by the plan shall be inspected. The number of defectives found in the first and second samples shall be accumulated. If the cumulative number of defectives is equal to or less than the second acceptance number, the lot or batch shall be considered acceptable. If the cumulative number of defectives is equal to or greater than the second rejection number, the lot or batch shall be rejected.
- 10.1.3 Multiple Sample Plan Under multiple sampling, the procedure shall be similar to that specified in 10.1.2, except that the number of successive samples required to reach a decision may be more than two.
- 10.1.4 Special Procedure for Reduced Inspection Under reduced inspection, the sampling procedure may terminate without either acceptance or rejection criteria having been met. In these circumstances, the lot or batch will be considered acceptable, but normal inspection will be reinstated starting with the next lot or batch [see 8.3.4 (b)].
- 10.2 Defects per Hundred Units Inspection To determine the acceptability of a lot or batch under defects per hundred units inspection, the procedure specified for percent defective inspection above shall be used, except that the word 'defects' shall be substituted for 'defectives'.

11. SUPPLEMENTARY INFORMATION

11.1 Operating Characteristic (OC) Curves — The operating characteristic curves for normal inspection, shown in Table 10, indicate the percentage of lots or batches which may be expected to be accepted under the various sampling plans for a given process quality. The curves shown are for single sampling; curves for double and multiple sampling are matched as closely as practicable. The OC curves

shown for AQLs greater than 10 are based on the Poisson distribution and are applicable for defects per hundred units inspection, those for AQLs of 10 or less, and sample sizes of 80 or less are based on the binomial distribution and are applicable for percent defective inspection; those for AQLs of 10 or less and sample sizes larger than 80 are based on the Poisson distribution and are applicable either for defects per hundred units inspection or for percent defective inspection (the Poisson distribution being an adequate approximation to the binomial distribution under these conditions).

Tabulated values, corresponding to selected values of probabilities of acceptance (Pa, in percent) are given for each of the curves shown and, in addition, for tightened inspection, and for defects per hundred units for AQLs of 10 or less and sample sizes of 80 or less.

11.2 Process Average — The process average is the average percent defective or average number of defects per hundred units (whichever is applicable) of product submitted by the supplier for original inspection. Original inspection is the first inspection of a particular quantity of product as distinguished from the inspection of product which has been resubmitted after prior rejection.

NOTE — It may also be useful to calculate the estimated process average which is normally defined as EPA = 100 multiplied by the number of defectives, or defects, in the samples from the most recent five consecutive batches and divided by the number of units of product in the samples from the same five batches. Resubmitted batches should not be included.

11.3 Average Outgoing Quality (AOQ)—The AOQ is the average quality of outgoing product including all accepted lots or batches, plus all rejected lots or batches after the rejected lots or batches have been effectively 100 percent inspected.

11.4 Average Outgoing Quality Limit (AOQL) — The AOQL is the maximum of

the AOQs for all possible incoming qualities for a given acceptance sampling plan. AOQL values are given in Table 5A for each of the single sampling plans for normal inspection and in Table 5B for each of the single sampling plans for tightened inspection.

11.5 Average Sample Size Curves — Average sample size curves for double and multiple sampling are in Table 9. These show the average sample sizes which may be expected to occur under the various sampling plans for a given process quality. The curves assume no curtailment of inspection and are approximate to the extent that they are based upon the Poisson distribution, and that the sample sizes for double and multiple sampling are assumed to be 0.631 n and 0.25 n respectively, where n is the equivalent single sample size.

11.6 Limiting Quality Protection - The sampling plans and associated procedures given in this standard were designed for use where the units of product are produced in a continuing series of lots or batches over a period of time. However, if the lot or batch is of an isolated nature, it is desirable to limit the selection of sampling plans to those, associated with a designated AQL value, that provide not less than a specified limiting quality protection. Sampling plans for this purpose may be selected by choosing a limiting quality (LQ) and a consumer's risk to be associated with it. Tables 6 and 7 give values of LQ for the commonly used consumer's risks of 10 percent and 5 percent respectively. If a different value of consumer's risk is required, the OC curves and their tabulated values may be used.

The concept of LQ may also be useful in specifying the AQL and inspection levels for a series of lots or batches, thus fixing minimum sample size where there is some reason for avoiding (with more than a given consumer's risk) more than a limiting proportion of defectives (or defects) in any single lot or batch.

TABLE 1 SAMPLE SIZE AND CODE LETTERS (Clauses 9.2 and 9.3)

LOT OF	R BATC	H SIZE	SPECIA	L INSPECTI	ON LEVEL	s	GENERAL	INSPECTIO	N LEVELS
	. 54,6	5,22	S –1	S-2	S-3	5-4	t	II.	ī ī ī
2	то	8	А	А	A	Α	А	А	В
9	TO	15	Α	Α	Α	À	Δ	В	С
16	TO	25	Α	A	В	В	В	С	D
26	TO	50	A	В	В	С	C	D	E
51	TO	90	В	В	С	С	С	E	F
91	TO	150	В	В	С	D	D	F	G
151	TO	280	В	С	D	E	Έ	Ġ	н
281	TO	500	В	С	D	E	F	н	J
501	TO	1 200	С	С	E	F	G	J	K
1 201	TO	3 200	С	٥	E	G	Н	K	L
3 201	то	10 000	C	D	F	6	J	L	. м
10 0 0 1	TO	35 000	С	D	F	н	К	М	N
35 001	ΤO	150 000	·D	Æ	G	J	L	N	P
150 001	TO	500 000	D	E E	G	1	М	P	Q 1R
500 001	and	over	D	E	Н	K	N	Q	198

	_									ACC	EPTAB	LE D	JALITY	LEV	ELS (NORMA	L INS	PECTIO	(אכ									
		SAMPLE		0.015	0.025	0.040	0.065	0.10	0 - 15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6.5	10	15	2 5	40	65	100	150	250	400	650	1000
	LETTER		Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	<u>Ac</u> Re	Ac Re	Ac Re	Ac Re
	A	2	Π	ln	l n	П	l n	П	П	П	П	П	П	n	Ϋ́	.♦.	0 1 公	Û	,➪,	1 2		-			10 11 14 15		21 22	l I
	B C	3 5												₹	0,	。 ①	Ŷ	1 2	2 3	3 4	5 6	i ·	1	1	21 22			. 1
٩	D	8]	1 11								1	0 1	4	くシ	1 2	2 3	3 4	5 6	7 8	10 11	14 15	21 22	30 31	44 45	47	
ANS	E	13									Jļ	₹5.	احٍ}^0	₹.	, Š,	1 2			5 6 7 8		10 11 14 15		21 22	30 31	44 45	Î		
	G	2 O 3 2									0 1	4	₹Ъ	1 2	2 3				10 11			 			֓֟֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓֓			
SIMPL	н	50							4	°谷¹	4	ζþι	1 2	2 3	3 4	5 6	7 8	10 11	14 15	21 22	42							
ES	J	80							0 1		<u> </u>	1 2		3 4 5 6	5 6		-	14 15		1								
S	K	125				1	0 . 1	。「 企	分	, ^C 2	1 2 2		5 6		10 11	1							1 11					
NGL	М	315			42	0 1	仑	Ŷ	1 V2	2 3	3 4	5 6			14 15	21 22	17											
듄	N P	500 800		\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	°√2¹	Ŷ	,₽,	1 2				_	10 11 14 15	14 15 21 22	_	1												
Z	a	1 2 5 0	0 1	47	Ŷ	, 🞝	2 3	i	-			_	21 22															
NORMAL	R	2 0 0 0	Î		1 2	2 3	3 4	5 6	7 8	10 11	14 15	21 22	Î				-											

= Use first sampling plan below arrow.If sample size equals or exceeds lot or batch size, do 100 percent inspection

= Use first sampling plan above arrow

Ac = Acceptance number

Re = Rejection number

_

Use first sampling plan below arrow. It sampling size equals or exceeds lot or batch size do 100 percent inspection

=Use first sampling plan above arrow

Ac = Acceptance number

Re = Rejection number

AMPLE	SAMPLE								ACCI	EPTAB	LE QU	ALITY	LEVE	.s(RE	DUCE	INSP	ECTIO	N) T									
SIZE	SIZE	0.010	0.01	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.:0	6.5	10	15	25	40	65	100	150	250	400	650	10
ETTER		Ac Re	Ac R	e Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac
A B	2 2	\prod	П			Ŋ	n l	Ŋ	Ŋ	Ŋ	n:	ln	Ŋ	Ŋ	٥Ŷ'	⁰ ۍ¹	N	᠐ᠿ	1 2	2 3	l .		Į	,	14 15 14 15		2 30
c	2												4	0 1	企	%	0 2	!	1 4		, ,	l -	J	ı	14 17		Į.
D s	3 5											\\ \\	소 아	Ŷ.	᠙ᠿ	0 2	· ·		2 5	_	i	l	l .		21 24	47	
F	8									1	0 1	"	쇼	0 2	í			2 5 3 6	1		10 13	l	14 17	21 24	1		
G	13	.					-	- }} }	4	الحک	ŶŢ,	ᢆᠿ	0 2	1 3	1 4		1			10 13	42		175				
H 1	20 32						ᅰ	, 3	°쇼'	Ŷ.	رٍ ۵	0 ~ 2		1 4 2 5	_ [3 6 5 8		7 10 10 13	10 13	17						.	1
K	50					4	°心	む	Л.	0 2																	
L	80			ואל	₹	°47	介	ŷ	0 \(2 \)	1 3		2 5	· [- 1	1	10 13	1			-							
M N	125		بال	0 1	0)		0 2		1 3	1 4	2 5 3 6			7 10	10 13	1	- }}	-									
Ρ	315	생	o ~i	₹	₹	°₽	1 3	1 4	- 1	3 6	1		10 13	\wedge	17											- -	
a	500	0 1	介	♡	0 ~2	1 3	1 4	2 5	3 6	5 8	7 10	10 13	4						-								
P	800	11	-	0 2	1 3	1 4	2 5	3 6	5 8	7 10	10 13	介															Ì
		ا "	u				- 1	- ({	- 1	l	ا ت	١ -	ا ت	· ·	١	ا "	١	u	۱			"	u	u	u	

 \int = Use first sampling plan below arrow. If sample size equals or exceeds lot or batch size, do 100 percent inspection

= Use first sampling plan above arrow

Ac = Acceptance number.

Re = Rejection number

t = If the acceptance number has been exceeded, but the rejection number has not been reached, accept the lot, but reinstate normal inspection (See 10.1.4)

IS: 10673 - 1983

TABLE 3A DOUBLE SAMPLING PLANS FOR NORMAL INSPECTION (MASTER TABLE) (Clauses 9.4 and 9.5)

s	AMPLE			CUMULA-						- //-		Δ.	CEPT	A RI F	OHAL	ITV I	EVEL	S (N	OPMA	ı ın	SPEC	TION								
	SIZE	SAMPLE	SAMPLE SIZE	TIVE	0.010	0.015	0.025	0000	0.065	0.10	0.15	T	0.40			1				Γ	T				1,00	1,50	1	400	650	1
L	ETTER			SIZE	0.010	0.013	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6.5	10	15	25	40	65	100	150	250	400	650	1000
L					Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac R€	Ac Re	Ac R	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re
L	Α				П		ln	וחו	П	n	ln	П	l n	n	ln	h	l n i	む	•	Π	仑	•	•	•	•	•	•	•	•	•
Γ	В	FIRST SECOND	2 2	2		$\ \ $											الملا	•	4	Ϋ́	0 2	0 3		2 5	1 -		7 11	_	l l	
 		FIRST	3	3													Ť	√	-	0 2	0 3	1 4		6 7 3 7	5 9		18 19 11 16			
-		SECOND FIRST	3 5	<u>6</u> 5	H								П			<u> </u>		<u> </u>	ᅺ	1 2	3 4	4 5					26 27		56 57	117
L	υį	SECOND	5	10											[↑ }	•	17	₽		0 3 3 4	1 1	2 5 6 7		12 13	7 11 18 19		17 22 37 38		介	
	E i	FIRST SECOND	8 8	8 16					- .					الح	•	分	Ŷ	0 20	3		17 71	٠,۱	5 9			17 22		4		
	F	FIRST	13	13]][Ť	42		0 Z	0 3	1 4		6 7 3 7			11 16	26 27	3/ 38	30 37			
┰├		SECOND	20	26									$\stackrel{\checkmark}{\cdot}$		<u>U</u>	0 √5	1 2 3		5 2 5				18 19 11 16	26 27	17	17	17			
∑L	''	SECOND	20	40								상		仓	₹}	1 2	3 4	4 5 6	5 7		12 13			17						
S	н і	FIRST SECOND	32 32	32 64							仆	. •	分	化	0 2	0 3		2 5 3 6 7 8			7 11 18 19	11 16	4			-				
ᇊ	,	FIRST.	50	50						仆	•	分	п	0 2	<u> </u>	-														
읾		SECOND	50 80	80						•	$\overline{}$		0 2	1 2 0 3	3 4	4 5 2 5					26 27	7[]								
딦		SECOND	80	160	Ш				∇		₹	<u> </u>	1 2	3 4	4 5	6 7	8 9	12 13 1	8 19		177									
Υု 	L I	FIRST SECOND	12.5 12.5	125 250				⟨₽	•	①	Û	02	0 3	1 4	- 1	- 1	5 9 1 12 13 1		1 16	47						-11-1				
	M I	FIRST	200	200			1	•	分	①	0 2	0 3		2 5	3 7	5 9	7 11	11 16					-						-11-1	
声는		SECOND FIRST	315	400 315			•	52	<u> </u>	0 2	1 2 0 3	3 4	2 5				18 19 2 11 16	26 27	\mathbb{I}											
ᆔ		SECOND FIRST	315	630		<u> </u>		U	<u>₹</u>	1 2		4 5	-			18 19	26 27	7												
Z Z	P	SECOND	500	500 1 000	₹	•	€	1	1 2	3 4	4 5	2 5 6 7	l	5 9 12 13			4													
æ	a i	FIRST	800	800	•	47	77	0 2 1	ſ	ſ				7 11	11 16	42														
<u> </u>	R	FIRST	1250	1 250	42		0 2		4	-				11 16	'															
L		SECOND	1250	2 500	<u> </u>	Ш	1 2	3 4	5	6 7	8 9	12 13	18 19	26 27	Ш	U	Ш	Ш	Ш	Ш	U	U		U	U	U	U		U	U

= Use first sampling plan below arrow. If sample size equals or exceeds lot or batch size, do 100 percent inspection.

= Use first sampling plan above arrow

Ac = Acceptance number

Re = Rejection number

 Use corresponding single sampling plan(or alternatively, use double sampling plan below, when available).

į	SAMPLE	}	1	CUMULA-	L								ACCEP	TABL	E QU	ALITY	LEVE	LS (T	IGHT	ENED	INSP	ECTI	ON)							1
	SIZE	SAMPLE	SAMPLE	TIVE SAMPLE	0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6.5	10	15	25	40	65	100	150	250	400	650	1000
Į	LETTER			SIZE	Ac Re	Ac R	e Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re
	Δ				N	Π		П	n	n		Π	N	N	Π	Π	П	Π	亇	П	Π	Ŷ	•	•	•	•	•	•	•	•
	В	FIRST SECOND	2 2	2															Ť		IJ,	0 2	0 3 3 4	1		1.		9 14 23 24		
	С	FIRST SECOND	3	3								Ш					1	·	П	1	0 2		-	2 5	3 7	6 10	9 14	15 20 34 35	23 29	4
Ī	D	FIRST SECOND	5	5 10													·	П		0 2	0 3	1 4	2 5	3 7	6 10	9 14	15 20	23 29	22 33	
t	F	FIRST SECOND	8	8												Ť	П		0 2	0 3			3 7	6 10	9 14	15 20	23 29	1 / 1	7[]	
ᇻ		FIRST	13	16											·	п		0 2	0 3	3 4	4 5 2 5				23 24	34 35	52 53	ווורו		
AN	-	SECOND FIRST	20	26										<u> </u>	n		0 2	0 3	3 4	4 5 2 5		11 12 6 10	-	23 24						
S	н	SECOND FIRST	20 32	32	١.								Ť			0 2		3 4	4 5 2 5			15 16 9 14	23 24							
함		FIRST	32 50	64 50								$\frac{\cdot}{\cdot}$	n		0 2	1 2 0 3	3 4	4 5 2 5			15 16 9 14	23 24	$ \hat{\mathbf{I}} $							
빰		SECOND FIRST	50 80	100 180][·	П		0 2	1 2	3 4	4 5 2 5			15 16 9 14	23 24	$ \hat{\mathbf{I}} $								
ES.		SECOND FIRST	8D 125	160 125			}			•	п		0 2	1 2 0 3	3 4	4 5			15 16 9 14	23 24	$ \hat{I} $:		
		SECOND FIRST	125 200	250 200					\vdash			<u>₹</u>	1 2 0 3		4 5 2 5	6 7	11 12	15 16 9 14		$ \uparrow $										
BUOD	М	SECOND	200	400				\vee	Ļ		₹	1 2	3 4	4 5	6 7	11 12	15 16	23 24	介											
E -	N	SECOND	315	630			3	•		₹₽	0 2 0	3 4	4 5		11 12	15 16		1												
=	P	FIRST SECOND	500 500	1000		∜	•	П	4	0 2	3 4	. 5	6 7	11 12	15 16	9 14 23 24	4		$\parallel \parallel \parallel$											
11911	u	FIRST SECOND	800 800	800 1 600	⟨\forall	•]	₹	0 2	1	- 1		1	5 10 15 16		介														
E	R	FIRST SECOND	1 250	1 250 2 500	•	む	4		0 3 3 4	3			6 10 15 16		仓															
	> 1	FIRST SECOND	2 000 2 000	2 000 4 00 0			0 2																-					-		ᅴ
_		11. 1																												1

TABLE 3 B DOUBLE SAMPLING PLANS FOR TIGHTENED INSPECTION (MASTER TABLE) (Clauses 9.4 and 9.5)

Use first sampling plan below arrow. If sample size equals or exceeds = lot or batch size, do 100 percent inspection

_ Use first sampling plan above arrow

Ac = Acceptance number

Re = Rejection number

Use corresponding single sampling plan (or afternatively, use double sampling plan below, when available)

TABLE 3C DOUBLE SAMPLING PLANS FOR REDUCED INSPECTION (MASTER TABLE) (Clauses 9.4 and 9.5)

SAMPLE	SAMPLE	SAMPLE	CUMULA-	L						AC	CEPT	ABLE	QUAL	ITY L	EVEL	S (RE	DUCE) INS	PEC	TION)	t								
ODE		SIZE	TIVE SAMPLE	0.010	0.01	0.025	0.040	0.065	0-10	0.15	0 - 25	0.40	0.65	1-0	1.5	2.5	4.0	6-5	10	15	2 5	40	65	100	150	250	400	650	10
ETTER			SIZE	Ac Fi	LE AC F	e Ac Re	AC R	Ac R	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	AC REA	c Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	; Ac
A B																Û	IスI	Ŷ	Û	Ŷ	•				•		•	•	
n :	FIRST SECOND	2 2	2												•	·	企	2		0 4 1 5]		2 7 6 9	1 -	5 10	I	11 17 26 30	4	- 2
F	FIRST SECOND	3	3										Ϋ́	•	仓	Ŷ	0 2 C 0 2 C	3 (0 4	1 5	2 7	3 8	5 10	7 12	11 17 26 30			
۲ .	FIRST SECOND FIRST	5 5 8	10									7	•	仓	介	0 2 0 2	0 4 1	_ 5	3 6		6 9	8 12	5 10 12 16	1 2 3 1	1	介			
-	SECOND FIRST	8	16 13								\ <u>\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\</u>		企	0 Z	_	0 4	0 4 0			6 9		12 16	介						
	SECOND FIRST	13	2 6 2 0							\ <u>`</u>		T.	0 2	0 2	0 4	1 5 0 4	3 6 4 1 5 2	7	69	8 12	12 16	Î							
к	SECOND FIRST SECOND	2 0 3 2 3 2	3 2 6 4						ř	1	₹ <u>₹</u>		0 2 0 3 0 4	0 4 0 4 1 5	1.	l' [2 7 3	- 1	5 10	12 16									
	FIRST SECOND	5 D 5 O	50 100				1	•	仓	Û		<u> </u>	0 4	0 4	1 5		1-		42										
M	FIRST SECOND		8 0 16 0			1	•	仓	介	0 2 0 2	0 4	1 5		4 7	6 9	8 12		☆											
N		125	1 2 5 2 5 0		7	•	企	む	0 2	0 3	1 5	3 6		6 9	8 12	12 16	4												
Р	SECOND	200	200 400 315	<u>•</u>	•	1		0 2	0 4	0 4		1 5 4 7	6 9	8 12	5 10 12 16														
0	SECOND	3 1 5	63 O 5 O O		-	0 2	0 2	0 4	1 5	3 6	4 7		8 12	12 16	Î														
		500 first s	1000	U	<u> </u>	0 2	0 4	1 5		4 7		8 12	12 16	ŢŢ,	<u>U</u>		Ш	U	Ш	<u> </u>	Ш	Ш	Ш	U	<u> </u>	Ш	Ш	Ш	<u> </u>

-Use first sampling plan above arrow

Ac = Acceptance number

= Rejection number

=Use corresponding single sampling plan (or alternatively, use double sampling plan below, when available).

mit, after the second sample, the acceptance number has been exceeded, but the rejection has not been reached, accept the lot, but reinstate normal inspection (see 10.1.4)

TABLE 4A MULTIPLE SAMPLING PLANS FOR NORMAL INSPECTION (MASTER TABLE) (Clauses 9.4 and 9.5)

ſ	SAMPLE	C 4 3 4 5 4 5	CANDI F	CUMULA-								Α	CCEPT	ABLE (JUAL I	TY LE	VELS	(NOR	MAL	INSPI	ECTIO	N)								
	SIZE CODE		SAMPLE SIZE	TIVE	0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1-0	1.5	2.5	4.0	6.5	10	15	25	40	65	100	150	250	400	650	1 000
	LETTER			SIZE	Ác Re	Ac R	z Ac Re	Ac R	z Ac Re	Ac Re	Ac Ro	Ac R	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re
	A B C																·	♡	. ⇔ç	<u>+</u> +	+ + + + \frac{+}{\triangle}	+ + + + +	+ + + +	+ + + +	+ + + +	• ++ ++	+ + + +	+ + + +	• ++ ++	+ -
	D	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	2222222	2 6 8 10 12 14											\	•			# 2 0 3 1 3	0 3 1 4 2 4 3 5 4 5	0 3 1 4 2 5 3 6 4 6 7	2 6 3 7 5 8 7 9	5 10 7 11 10 12 13 14	11 15 14 17 18 19	8 13 12 17 17 20 21 23 25 26	13 19 19 25 25 29 31 33 37 38	11 19 19 27 27 34 36 40 45 47 53 54		<u></u>	
PLA	E	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	തത്തത്തന്ന് മ	3 6 9 12 15 18 21											•		<u>></u>	0 3 1 3 1 3	0 3 0 3 1 4	2 5 3 6 4 6	1 5 2 6 3 7 5 8 7 9	10 12	6 10 8 13 111 15 214 17	4 10 8 13 12 17 17 20 21 23	2 9 7 14 13 19 19 25 25 29 31 33 37 38	11 19 19 27 27 34 36 40 45 47	6 16 17 27 29 39 40 49 53 58 65 68 77 78			
ANS MULTIPLE		FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	5555555	5 15 15 22 30 35										•			0 2	0 3	0 3 1 4 2 5 3 6	5 8	1 6 3 8 5 10 7 11 10 12	3 8 6 10 8 13	1 4 10 8 13 112 17 5 17 20	2 9 7 14 13 19 19 25 25 29 31 33 37 38						
ES-		FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	888888888	8 16 24 32 40 48 56									•		$\longrightarrow \hspace{-0.5cm} \searrow$	# 2 0 2 0 3 1 3 1 3 2 3	0 3 0 3 1 4 2 4 3 5	0 3 1 4 2 5 3 6	2 6 3 7 5 8 7 9	3 8 5 10 7 11 10 12	8 13 11 15 14 17	4 10 8 13 12 17 17 20 21 23	7 2 9 7 14 8 13 19 7 19 25 0 25 29 8 31 33 6 37 38	1						
MULTIPLE NO	н	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	13 13 13 13 13 13	1369 2352 5678 91								·				0 3	0 3 1 4 2 5 3 6 4	2 6 3 7 5 8	1 6 3 8 5 10 7 11 10 12	8 13 11 15 14 17 18 19	8 13 12 17 17 20 21 23 25 26	7 14 13 19 19 25 25 29 31 33 37 38								
NORMAL	j	FIRST SECOND I HIRD FOURT H FIFTH SIXTH SEVENTH	20 20 20 20 20 20 20 20	20 40 60 80 100 120 140							•	Î	Ũ,	lo 3'	0 3 1 4 2 4	# 3 0 3 1 2 3 6 6 7	1 5 2 6 3 7 5 8 7 9	0 4 1 6 3 8 5 10 7 11 10 12 13 14	6 10 8 13 11 15 14 17	8 13 12 17 17 20 21 23	2 9 7 14 13 19 19 25 25 29 31 33 37 38	17								

= Use first sampling plan below arrow (refer to contination of table on following page, when necessary)If sample size equals or exceeds lot or batch size, do 100 percent inspection.

= Use first sampling plan above arrow

Ac = Acceptance number

Re = Rejection number

• 度 Use corresponding single sampling planfor afternatively, use multiple sampling plan below, where available).

+ + = Use corresponding double sampling plan (or alternatively, use multiple sampling plan below, where available).

= Acceptance not permitted at this sample size.

TABLE 4A MULTIPLE SAMPLING PLANS FOR NORMAL INSPECTION (MASTER TABLE) (Continued)

SAMPL		AMPLE	SAMPLE	CHMIN A-								Ą	CCEPT	ABL E	QUAL	TY LE	VELS	(N C	DRMA	INSF	ECTI	ON)								
SIZE	E	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		TIVE SAMPLE	0.010	0.015	0.025	0.040	0.065	0.10	0.15	0,25	0.40	0.65	1.0	1.5	2.5	4.0	6,5	10	15	25	40	65	100	150	250	400	650	1 000
LETTE	R			SIZE	Ac Re	Ac R	e Ac Re	Ac R	e Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re				Ac Re	Ac R	e Ac Re	Ac R						
K	SE TH FO FI SI	IRST ECOND HIRD OURTH IF TH IXTH EVENTH	32 32 32 32 32 32 32	32 64 96 128 160 192 224						•		$\qquad \qquad \Longrightarrow$	1 3	#001234 55	0 3 1 4 2 5 6	1 5 6 7 5 8 7 9 10	1 6 3 8 5 10 7 11 10 12 13 14	8 1 11 1 14 1	3 12 5 17 2 7 21 2	7 2 10 7 17 13 13 15 15 15 15 15 15 15 15 15 15 15 15 15										
Ĺ	SE TH FO FII SI	RST ECOND HIRD OURTH IFTH XTH EVENTH	50 50 50 50 50 50 50	50 100 150 200 250 300 350					•			0 2 0 3	0 3 0 3 1 4 2 4 3 5	2 5 3 6	1 5 2 6 3 7 5 8 7 9	5 10 7 11 10 12	6 10 8 13 11 15 14 17	8 1 12 1 17 2 21 2	7 2 0 7 1 3 13 1 7 19 2 0 25 2 3 31 3 6 37 3	9 7										
М	SE TH FO FIF SI)	RST ECOND IIRD OURTH FTH XTH VENTH	80 80 80 80 80 80	80 160 240 320 400 480 560				•	Î		# 00	1 4	# 3 0 1 2 3 4 5 6 7	1 5 2 6 3 7 5 8 7	0 4 1 6 3 8 5 10 7 11 10 12 13 14	3 8 6 10 8 13 11 15 14 17	4 10 8 13 12 17 17 20	7 14 13 19 19 29 25 29 31 3	9 5 9 3											
Z	SE TH FO FIF S1)	RST COND HIRD OURTH FTH XTH VENTH	125 125 125 125 125 125 125	125 250 375 500 625 750 875			•	Î	Ů,	# 2 0 2 0 3	0 3 0 3 1 4	0 3 1 4 2 5 3 6 4 6	2 6	1 6 3 8 5 10 7 11 10 12	3 8 6 10 8 13	4 10 8 13	7 14 13 19 19 25	Î												
P	SE TH FO FIF SIX	RST COND IIRD JURTH FTH XTH VENTH	200 200 200 200 200 200 200 200	200 400 600 8 00 1 000 1 200 1 400		•		Ĵ	# 2 # 2 0 2 0 3 1 3 1 3 2 3	0 3 0 3 1 4 2 4	0 3 1 4 2 5 3 6	2 6 3 7 5 8 7 9	1 6 3 8 5 10 7 11 10 12	3 8 6 10 8 13 11 15	8 13 12 17 17 20 21 23	7 14 13 19 19 25 25 29 31 33	Î													
Q	SEC TH FO FIF SIX	RST COND URD URTH FTH XTH VENTH	315 315 315 315 315 315 315	315 630 945 1260 1575 1890 2205	•	Ŷ		# 2 0 2 0 3 1 3	# 2 0 3 0 3 1 4 2 4 5 4 5	0 3 1 4 5 6 6	2 6 3 7 5 8 7 9	1 6 3 8 5 10	3 8 6 10 8 13 11 15 14 17	4 10 8 13 12 17 17 20	13 19 19 25 25 29 31 33	Î														
р	SEC THI FOU FIF SIX	RST COND IRD URTH TIH KTH VENTH	500 500	500 1 000 1 500 2 000 2 500 3 000 3 500			0 3	0 3 0 3 1 4 2 4	# 3 0 3 1 4 2 5 3 6 4 6 7	1 5 2 6 3 7 5 8 7 9	1 6	3 8 6 10 8 13 11 15 14 17	4 10 8 13 12 17 17 20	13 19 19 25 25 29 31 33	Î															

Use first sampling plan below arrow it sample size equals or exceeds lot or batch size, do 100 percent inspection

 $[\]Upsilon$ = Use first sampling plan above arrow(refer to preceding page, when necessary)

Ac = Acceptance number

Re = Rejection number.

Use corresponding single sampling plan(or alternatively, use multiple plan below, when available).
 Acceptance not permitted at this sample size.

-Use first sampling plan below arrow (refer to continuation of table on following page, when necessary).

If sample size equals or exceeds lot or batch size, do 100 percent inspection.

± Use first sampling plan above arrow:

Ac = Acceptance number

Re = Rejection number

=Use corresponding single sampling plan (or alternatively, use multiple sampling plan below, where available).

--- = Use corresponding double sampling plan (or alternatively, use multiple sampling plan below, where available).
= Acceptance not permitted at this sample size.

Š
••
_
8
0
-1
Ç
•
1
9
83
ಌ

AMPLE	SAMPLE	SAMPLE	CUMULA-						ACCEP	TABLE	QUA	LITY L	EVEL	s (TIG	HTEN	ED IN	SPEC	TION									 ,		
SIZE CODE ETTER		SIZE	TIVE SAMPLE SIZE	0.010	0.01	0.025	0.04	0.06	5 0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6-5	10	15	25	40	65	100	150	250	400	650	100
				Ac R	e Ac R	e Ac Re	Ac F	e Ac F	Re Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re							Ac R	Ac Re	Ac Re	Ac					
K	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	32 32 32 32 32 32 32 32	32 64 96 128 160 192 224							•		\	# 22 0 3 1 3 1 3	# 23 00 12 34 4 5	0 1 2 3 4 5 6 6	2 6 3 7 5 8	4 9 6 11 9 12 12 14	7 12 10 15 14 1 18 20	1 8 6 12 11 17 16 22 7 22 25 0 27 29 1 32 33		Î	Î	Î						
ί	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	50 50 50 50 50 50	50 100 150 200 250 300 350						,		J		0 3	0 3 1 2 3 6 6 7	1 5 2 7 5 8 9 10	6 11 9 12 14 15	3 9 7 12 10 15 14 17 18 20 21 22	6 12 11 17 16 22 27 29 32 33	1 22										
М	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	80 800 800 800 800 800	80 160 240 320 400 480 560					•			# 2 0 3 1 3	0 3 1 4 2 4 3 5	0 3	# 567 5 7 8 9 10	2 7 4 9 6 11 9 12 12 14 14 15	21 22	1 8 6 12 11 17 16 22 22 25 27 29 32 33	1											
N	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	125 125 125 125 125 125 125	125 250 375 500 625 750 875				•			# 2 0 3 1 3 1 3 2 3	0 3 4 4 2 3 4 5	0 3 4 2 5 6 7	1 5 2 6 3 7 5 8 7 9	6 11 9 12 12 14 14 15	0 6 3 9 7 12 10 15 14 17 18 20 21 22	6 12													
Р	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	200 200 200 200 200 200 200	200 400 600 800 1 000 1 200 1 400		\downarrow	•			# 2 0 2 0 3 1 3 1 3 2 3	0 3 1 4 2 4 3 5 4 5	0 3 1 4 2 5 3 6 4 6 6 7	2 6 3 7 5 8 7 9	12 14 14 15	7 12 10 15 14 17 18 20 21 22	1 8 6 12 11 17 16 22 22 25 27 29 32 33	1													
Q	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	315 315 315 315 315 315 315	315 630 945 1 260 1 575 1 890 2 205	Ů,	•			# # 0 0 1 1	2 0 3 3 1 4 3 2 4 3 3 5 3 4 5	# 3 1 2 3 4 5 6 7	1 5 2 6 3 7 5 8	2 7 4 9 6 11 9 12 12 14 14 1 5	7 12 10 15 14 17 18 20 21 22	6 12 11 17 16 22 22 25 27 29															
R	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	500 500 500 500 500 500 500	500 1 000 1 5000 2 5000 3 500	•			0	2 0 3 1 3 2 3 3	3 0 3 3 1 4 4 2 5 4 3 6 5 4 6	# 4 1 5 2 6 3 7 5 8 7 9 9 10	2 7 4 9 6 11 9 12	7 12 10 15 14 17	1 8 6 12 11 17 16 22 22 25 2 7 29 32 33	Î															
5	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	800 800 800 800 800 800 800	800 1 600 2 400 3 200 4 000 4 800 5 600			# 22 Q 23 1 3 1 3 2 3																							

Use first sampling plan below arrow. If sample size equals or exceeds lot or batch size, do 100 percent inspection.

To a Use first sampling plan above arrow(refer to preceding page, when necessary).

Ac = Acceptance number

Re = Rejection number.

 Use corresponding single sampling plan(or alternatively, use double sampling plan below, when available).

= Acceptance not permitted at this sample size.

TABLE 4C MULTIPLE	SAMPLING PLANS	FOR REDUCED	INSPECTION (MAS	TER TABLE)
	(Clauses 9.4	and 9.5)		

	·										Ciac		. 4 ar	<u></u>															
SAMPLE	SAMPLE	SAMPLE	CUMULA-				,		AC	CEPT	ABLE	QUALI	TY LE	VELS	REDU	ICED	INSPE	CTIO	N)										
SIZE CODE LETTER		SIZE	SAMPLE SIZE	0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6.5	10	15	25	40	65	100	150	250	400	650	1 00
LLITER				Ac R	e Ac Ri	Ac Re	Ac R	e Ac Re	Ac Re	Ác R	Ac R	e Ac Re	Ac Re	Ac Re	.4c Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac e	Ac e	Ac Re	Ac Re	Ac Re	Ac R
A B C D E														•		₹	₹ \$ 1 \$+	• <\$\chi\$+ + +	++	÷ + + + + + + + + + + + + + + + + + + +	+++	+++	+++	• • ++ ++	• • ++ ++	• • • + + + +	• • • •	· ·	: Î
	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	2 2 2 2 2 2 2 2	2 4 6 8 10 12 14										•			0 3	0 3 0 4 0 4 1 5	# 3 0 4 0 5 1 6	0 5 1 6	2 7 3 8 4 9	2 8 3 10 5 11 7 12	3 9 5 12 7 13 10 15	11 17	Î	Î	Î			
	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	3 3 3 3 3	3 6 9 12 15 18 21									•	Î		# 2 # 2 0 2 0 3 0 3	# 3 0 3	# 3 0 4 0 5 1 6	# 3 0 4 0 5 1 6 2 7 3 7 4 8	# 4 0 5 1 6 2 7 3 8 4 9	# 4 1 6 2 8 3 10 5 11 7 12	0 5 1 7 3 9 5 12 7 13 10 15	0 6 3 9 6 12 8 15							
	FIRST SECOND THIRD FORTH FIFTH SIXTH SEVENTH	5555555	5 10 15 20 25 30 35							 	•	Î			# 2 # 3 0 3 0 4 1 5	# 3 0 5 1 6	0 5 1 6 2 7	# 4 0 5 1 6 2 7	# 4 1 6 2 8 3 10 5 11 7 12	0 5 1 7 3 9 5 12 7 13	0 5 3 9 6 12 8 15	<u> </u>							
	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	8 8 8 8 8 8	8 16 24 32 40 48 56							•	Î		# 2 = # 2 0 2 0 3 0 3 0 3 1 3		# 3 0 4 0 5 1 6	0 4 0 5 1 6 2 7 3 7	# 4 0 5 1 6 2 7 3 8 4 9	# 4 1 6 2 8 3 10 5 11 7 12	0 5 1 7 3 9 5 12 7 13	0 6 3 9 6 12 8 15	Î								
	FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	13 13 13 13 13 13 13	13 26 39 52 65 78 91						•			# 2 0 2 0 3	# 2 # 3 0 3 0 0 4 0 0 4 1 5 1 1 5 1	# 3 0 0 5 1 1 6 3	5 6 7	0 5 1 6 2 7 3 8 4 9	1 6 2 8 3 10 5 11	0 5 1 1 7 3 3 9 6 5 12 8 7 13 1 10 15 1	0 6 3 9 5 12 3 15 1 17 4 20										

Use first sampling plan below arrow (refer to continuation of table on following page, when necessary).

If sample size equals or exceeds lot or batch size, do 100 percent inspection.

🔂 😑 Use first sampling plan above arrow

Ac = Acceptance number.

Re = Rejection number.

= Use corresponding single sampling plan (or alternatively, use multiple sampling plan below, when available).

= Acceptance not permitted at this sample size.

+ = If, after the final sample, the acceptance number has been exceeded, but the rejection number has not been reached, accept the lot, but reinstate normal inspection (see 10.1.4)

												AC	CEPTA	BLE	QUAL	ITY LE	VELS	(RED	UCED	INS	PECTI	ON)								
	SAMPLE SIZE		SAMPLE SIZE	TIVE	0.010	0.015	0.025	0.040	0.065	0.10	0.15	0 -2 5	0.40	0.65	1.0	1.5	2.5	4.0	6.5	10	15	2 5	40	6.5	100	150	250	400	650	1000
	CODE LETTER			SAMPLE SIZE		Ac R	e Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Ra	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac R	e AcRe	Ac R	e Ac Re	Ac Re	Ac Re	Ac R	e Ac Re	Ac Re				
		FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	2 0 2 0 2 0 2 0 2 0 2 0 2 0 2 0	20 40 60 80 100 120 140				\$	•	Î	1	# 2 # 2 0 2 0 3 0 3 0 3	0 3 0 4 0 4 1 5	# 3 0 4 0 5 1 6 1 6 2 7	0 4 0 5 1 6 2 7 3 7 4 8	0 5 1 6 2 7 3 8 4 9 6 10	1 6 2 8 3 10 5 11 7 12 9 14	1 7 3 9 5 12 7 13 10 15 13 17	0 0 0 7 3 9 6 12 8 11 3 11 1 5 14 21 7 18 22	5 7										
P		FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	32 32 32 32 32 32 32 32	3 2 6 4 9 6 12 8 1 6 0 † 9 2 2 2 4				•			0 2 0 3	##0001 1	0 4 0 5 1 6	0 5	0 5 1 6 2 7 3 8	1 6 2 8 3 10 5 11 7 12	0 5 1 7 3 9 5 12 7 13 10 15 13 17	6 12 8 15 11 17	5											
ANS MULTIP	.,	FIRST SECOND THIRD FOURTH FIFTH SIX TH SEVENTH	50 50 50 50 50 50	50 100 150 200 250 300 350			•	Î		# 2 0 2 0 3	# 3 0 3 0 4 0 4	# 3 0 5 1 6	0 4 0 5 1 6 2 7 3 7	# 4 0 5 1 7 3 8 4 10	1 6 2 8 3 10 5 11 7 12	3 9 5 12 7 13 10 15	3 9 6 12 8 15	$\hat{\parallel}$	-											
LES-		FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	80 80 80 80 80 80	80 160 240 320 400 480 560		•		1	# 2 0 2 0 3	# 3 0 3 0 4 0 4 1 5	# 3 0 4 0 5 1 6 1 6	0 5 1 6 2 7	2 7 3 8 4 9	# 4 1 6 2 8 3 10 5 11 7 12	0 5 1 7 3 9 5 12 7 13 10 15	0 6 3 9 6 12 8 15														
MULTIPLE RE		FIRST SECOND THIRD FOURTH FIFTH SIXTH SEVENTH	125 125 125 125 125 125 125	125 250 375 500 625 750 875	•	Î		# 2 7 2 0 3 0 3 0 3 1 3	0 4	# 3 0 4 0 5 1 6 1 6	0 4 0 5 1 6 2 7 3 7	0 5 1 6 2 7 3 8 4 9	1 6 2 8 3 10 5 11 7 12	3 9	3 9 6 12 8 15 11 17 14 20															
DUCED			200 200 200 200 200 200 200 200 200	2 0 0 4 0 0 6 0 0 8 0 0 1 0 0 0 1 2 0 0 1 4 0 0	Î		# 2 0 2 0 3	0 4 0	# 3 0 5 1 6	0 4 0 5 1 6 2 7	0 5 1 6 2 7 3 8	3 10 5 11 7 12	5 12 7 13	3 9 6 12 8 15 11 17 14 20																

 $[\]Phi$

23

_Use first sampling plan below arrow.If sample size equals or exceeds tot ar batch size, do 100 percent inspection.

wise first sampling plan above arrow (refer to preceding page, when necessary).

Ac =Acceptance number.

Re =Rejection number.

= Acceptance not permitted at this sample size.

=If, after the final sample, the acceptance number has been exceeded, but the rejection number has not been reached, accept the lot, but reinstate normal inspection (see 10.1.4)

Use corresponding single sampling plan(or alternatively, use multiple sampling plan below, when available).

TABLE 5A AVERAGE OUTGOING QUALITY LIMIT FACTORS FOR NORMAL INSPECTION (SINGLE SAMPLING) (Clause 11.4)

,		SAMPLE									ACC	EPTA	BLE C	UALIT	Y LEV	ĒL												
	LETTER		0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6.5	10	15	25	40	65	100	150	2 50	400	650	1 000
	Α	2															18			42	69	97	160	220	330	470	730	1100
	В	3														12			28	46	65	110	150	220	310	490	7 20	1 100
	С	5							i		.*				7.4			17	2 7	39	63	90	130	190	290	430	660	
	D	8												4.6			11	17	24	40	56	82	120	180	270	410		
	Ε	13											2.8			6.5	11	15	24	34	5 0	72	110	170	250			
	F	20										1-8			4.2	6.9	9.7	16	22	33	47	7:3						
	G	32									1-2			2.6	4.3	6.1	9.9	14	21	29	46							
	н	50								0.74			1.7	2.7	3.9	6.3	9.0	13	19	29								
	J	80							0.46			1.1	1.7	2.4	4.0	5.6	8.2	12	18									
•	К	12 5						0.29			0.67	1.1	1.6	2.5	3.6	5.2	7.5	12										
	L	200					0.18			0.42	0.69	0.97	1.6	2.2	3.3	4.7	7.3											
	м	315				0.12			0.27	0.44	0.62	1.00	1.4	2.1	3.0	4.7												
Þ	N	500			0.074			0.17	0.27	0.39	0.63	0.90	1.3	1.9	2.9													
100	Р	800		0.046			0.11	0.17	0.24	0.40	0.56	0.82	1.2	1.8							-							
	Q	1250	0.029			0.067	0.11	0.16	0.25	0.36	0.52	0.75	1.2															
NORMAL	R	2 000			0.042	0.069	0.097	0.16	0.22	0.33	0.47	0.73																

 ${f NOTE-}$ For the exact AOQL, the above values should be multiplied by

(1 - sample size

co	DE TER	SAMPLE								······································	A	CEPT	ABLE	QUAL	ITY LI	EVEL					····							
LEI	IER		0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6,5	10	15	25	40	65	100	150	250	400	650	1 000
1	Δ.	2																			42	69	97	160	260	400	620	970
E 0	- 1	3 5														7.4	12		17	28	46 39	65 63	110 100	170 160	270 250	410 390	650 610	1 100
		3														7:4											610	
	·	8													4.6			11	17	24	40	64	99	160	240	380		
1	Ε	13												2.8			6.5	11	15	24	40	61	95	150	240			
F		20								•			1.8			4.2	6.9	9.7	16	26	40	62						
G	;	32										1.2			2.6	4.3	6.1	9.9	16	25	39							
	1	50							ļ [0.74			1.7	2.7	3.9	6.3	10	16	25								İ
١ ١	1	80								0,46			1.1	1.7	2.4	4-0	6.4	9.9	16]
H	,	125							0.29			0.67	1.1	1.6	2.5	4.1	6.4	9.9		•								
L		200					1 1	0.18			0.42			1.6	2.6	4.0	6.2											
^	И	315					0.12			0.27	0.44	0.62	1.0	1.6	2.5	3.9												
5 \	,	500				0.074			0.17	0.27	0.39	0.63	1.0	1.6	2.5													
- P	,	800		ľ	0.046			0.11	0-17	0.24	0.40	0.64	0.99	1.6														
R	1	1250		0.029			0.067	0.11	0.16	0.25	0.41	0.64	0.99															
R	,	2 000	0.018			0.042	0.069	0.097	0.16	0.26	0.40	0.62																,
[] s	,	3 150			0.027																							
											_																	

NOTE - For the exact AOQL, the above values should be multiplied by

TABLE 6A LIMITING QUALITY (IN PERCENT DEFECTIVE) FOR WHICH P2=10 PERCENT (FOR NORMAL INSPECTION, SINGLE SAMPLING) (Clause 11.6)

	CODE	SAMPLE						ACCE	PTABL	E QUA	LITY	LEVE						
	LET TER		0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6.5	10
	Α	2															68	
	В	3											-			54		
	С	5 .													37			58
	ם	8	ĺ .											25			41	54
	E	13											16			27	36	44
	F	20			[ļ	11		1	18	25	30	42
	G	32			ĺ						6.9			12	16	20	27	34
LQ (DEFECTIVES) P	н	50	i							4.5			7.6	10	13	18	22	29
30	J	80	l			1			2.8			4.8	6.5	8.2	11	14	19	24 .
E.	κ	1-25	l			İ		1.8			3.1	4.3	5.4	7.4	9.4	12	16	23
3	L	200		 			1.2			2.0	2.7	3.3	4.6	5.9	7.7	10	14	
ÆS	М	315	,			0.73			1.2	1.7	2.1	2.9	3.7	4.9	6.4	9.0		
, P	N	500			0.46			0.78	1.1	1.3	1.9	2.4	3.1	4.0	5.6			
п	Р	800		0.29			0.49	0.67	0.84	1.2	1.5	1.9	2.5	3.5				
10.0	Q	1250	0.18			0.31	0.43	0.53	0.74	0.94	1.2	1.6	2.3					
PERCENT	R	2 000			0.20	0.27	0.33	0.46	0.59	0.77	1.0	1.4						

TABLE 6B LIMITING QUALITY (IN DEFECTS PER HUNDRED UNITS) FOR WHICH Pa=10 PERCENT (For normal inspection, single sampling) (Clause 11.6)

ſ	_										Δ.(CEPTA	BIF (TIAII	TY LF	VFL												
1	CODE LETTER	SAMPLE SIZE		Γ	Γ	1	Γ	T	ι	I		1		I	T					<u> </u>	· · · · · · · · · · · · · · · · · · ·				<u> </u>			[
- 1			0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2.5	4.0	6.5	10	15	25	40	65	100	150	250	400	650	1 000
ľ	А	2															120			200	270	330	460	590		1000		
	В	3														77			130	180	220	310	390	510	670	940	1300	1800
	С	5													46			78	110	130	190	240	310	400	560	770	1100	
Ī	D	8	1											29			49	67	84	120	150	190	250	350	480	670		
	Ē	13											18			30	41	51	71	91	120	160	220	300	410			
1	F	20			<u> </u> 							12			20	27	33	46	59	77	100	140						
T	G	32	1								7. 2			12	17	21	29	37	48	63	88							
	н	50								4.6			7.8	11	13	19	24	31	40	56								
-	J	80							2.9			4.9	6.7	8.4	12	15	19	25	35									
ı	к	125						1.8			3.1	4.3	5.4	7.4	9.4	12	16	23			:							
	L	200					1.2			2.0	2.7	3.3	4.6	5.9	7.7	10	14											
LO(DE FEC IS) Pa	м	315				0.73			1,2	1.7	2.1	2.9	3.7	4.9	6.4	9.0												
삒	Ń	500	1		0.46			0.78	1.1	1.3	1.9	2.4	3.1	4.0	5.6													
	Р	800		0.29			0.49	0.67	0-84	1.2	1.5	1.9	2.5	3.5								,						
SP	Q	1250	0.18			0.31	0.43	0.53	0.74	0.94	1.2	1.6	2.3															
= 10 PERCE	R	2 000			0.20	0.27	0.33	0.46	0.59	0.77	1.0	1.4																

TABLE 7A LIMITING QUALITY (IN PERCENT DEFECTIVE) FOR WHICH	Pa = 5 PERCENT
(FOR NORMAL INSPECTION, SINGLE SAMPLING)	-
(Clause 11-6)	

	CODE LETTER	SAMPLE						ACCE	PTABL	E QU	ALITY	LEVE	L					
		. 1	0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0,65	1.0	1.5	2.5	4.0	6.5	10
	Α	2															78	
	В	3														63		
	С	5													45	ļ		66
	D	8			 									31			47	60
	Ε	13											21			32	41	50
	F	20										14			22	28	34	46
	G	32									8.9			14	18	23	30	37
ြ	н	50		ŀ						5.8			9.1	12	15	20	25	32
Ō	ر	80							3.7			5.8	7.7	9.4	13	16	20	26
田田	К	125				ŀ		2.4]	3.8	5.0	6.2	8.4	11	14	18	24
0	L	200					1.5			2.4	3.2	3.9	5.3	6.6	8.5	11	15	
₹	М	315				0.95			1.5	2.0	2.5	3.3	4.2	5.4	7.0	9.6		
ES	N	500			0.60			0.95	1.3	1.6	2.1	2.6	3.4	4.4	6.1			Ì
7	Р	800		0.38	l		0.59	0.79	0.97	1.3	1.6	2.1	2.7	3.8				
<u>ا</u>	Q	1250	0.24			0.38	0.50	0.62	0.84	1.1	1.4	1.8	2.4					
LQ (DEFECTIVES) Pa=5.0 PERCEN	R	2 000			0.24	0.32	0.39	0.53	0.66	0.85	1.1	1.5						

TABLE 7B LIMITING QUALITY (IN DEFECTS PER HUNDRED UNITS) FOR WHICH $P_a = 5$ PERCENT (For normal inspection, single sampling) (Clause 11.6)

cot	DE !	SAMPLE									ACCE	PTAB	LE QU	ALITY	LEVE	L												
LETT	ER	SIDE	0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1.0	1.5	2,5	4.0	6.5	10	15	25	40	65	100	150	250	400	650	1000
A		2															150			240	320	390	530	660	850	1 100	1 500	2 000
В		3					<u> </u>									100			160	210	260	350	440	570	730	1 000	1 400	1 900
C		5													60			95	130	160	210	260	340	440	610	810	1 100	
D		8												38			59	79	97	130	160	210	270	380	510	710		
E		13											2 3			37	48	60	81	100	130	170	230	310	440			
F		20										15			24	32	39	53	66	85	110	150						
G		32									9.4			15	20	24	33	41	53	68	95		,					
Н	- }	50								6.0			9.5	13	16	21	26	34	44	61								
ر	}	80]		3.8			5.9	7.9	9.7	13	16	21	27	38									
K		125						2-4			3.8	5.0	6.2	8.4	11	14	18	24										
L	ļ	200	,		1		1.5			2.4	3.2	3.9	5.3	6.6	8.5	11	15											
5		315			<u> </u>	0.95			1.5	2.0	2.5	3.3	4.2	5.4	7.0	9.6												
I N		500			0.60			0.95	1.3	1.6	2.1	2.6	3.4	4.4	6.1			!										
P		800		0-38			0.59		0.97	1.3	1.6	2.1	2.7	3.8			1											
P		1250	0.24			0.38	0.50	0.62	0.84	1.1	1.4	1.8	2.4															
0					•																	i						
B B B B B B B B B B B B B B B B B B B		2 000			0.24	0.32	0.39	0.53	0.66	0.85	1-1	1.5						,										
Ď																												

TABLE 8 LIMIT NUMBERS FOR REDUCED INSPECTION (Clause 8:33)

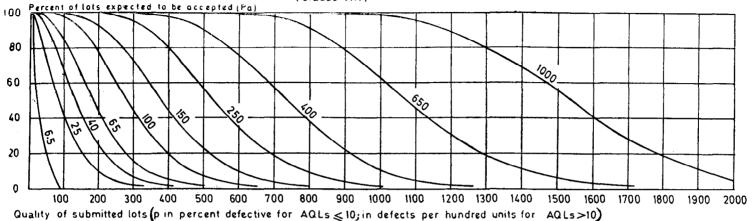
	,									iuuse		<u> </u>														
NUMBER OF SAMPLE UNITS		,	1	,		_	,		ACCER	TABLE	QUA	LITY	LEVEL		·		·			T	·	 	r	·		
FROM LAST 10 LOTS OR BATCHES	0.010	0.015	0.025	0.040	0.065	0.10	0.15	0.25	0.40	0.65	1-0	1.5	2.5	4.0	6.5	10	15	25	40	65	100	150	250	400	650	1 000
20 - 29 30 - 49				:				•	:			:		:		0	0	2 3	4 7	8	14 22	22 36	40 63	68	115	181 277
50 - 79		•				•		•			•	•	•	0	0	2	3	7	14	25	40	63	110	181	301	
80 — 12 9		•							•				0	0	2	4	7	14	24	42	68	105	181	297		
130 — 199 200 — 319							:	•	•		0	0	2	2	8	14	13 22	25 40	42 68	115	115	177 277	301 471	490		
320- 499										0	0	1	4	8	14	24	39	68	113	189						
500 — 799 800 — 1 2 4 9									0	0 2	2	3	7	14	25 42	40 68	63 105	110	181							
1 250 - 1 999					•		0	0	2	4	7	13	24	40	69	110	169									
2 000-3 149		•				0	0	2	4	8	14	22	40	68	115	181	103)					
3 150-4 999	•	•	•	•	0	0	1	4	8	14	24	38	67	111	186		ļ		,							
5 000 - 7 999 8 000 - 12 499	•		0	0	0 2	2	3 7	7	14	25 42	40 68	63 105	110 181	181												
		0	0	2	4	7	13	24	40	69	110	169	101													
12500-19 999 20 000-31 499	0	0	2	4	8	14	22	40	68	115	181															
31 500-49 999	0	1	4	8	14	24	38	67	111	186												}				- 1
≥50000	2	3	7	14	25	40	63	110	181	301																

[•] Denotes that the number of sample units from the last 10 lots or batches is not sufficient for reduced inspection for this AQL. In this instance, more than 10 lots or batches may be used for the calculation, provided that the lots or batches used are the most recent ones in sequence, that they have all been on normal inspection, and that none has been rejected while on original inspection.

TABLE 9

Ω

IS: 10673 - 1983



NOTE - Figures on curves are Acceptable Quality levels (AQLs) for normal inspection.

TABLE 10 A -1 TABULATED VALUES FOR OPERATING CHARACTERISTICS CURVES FOR SINGLE SAMPLING PLANS (Clause 11-1)

	ACCEPTABLE QUALITY LEVELS (NORMAL INSPECTION)														
$P_{\mathbf{a}}$	6.5	6.5	25	40	65	100	150	> <	250	\supset	400	$\supset \subset$	650	\supset	1 000
	p (In Percent Defective)	p (Indefects per Hundred Units)													
99.0	0.501	0.51	7.45	21.8	41.2	89.2	145	175	239	305	374	517	629	859	977
95.0	2.53	2.56	17.8	40.9	68.3	131	199	235	308	385	462	622	745	995	1 122
90.0	5,13	5.25	26.6	55.1	87.3	158	233	272	351	432	515	684	812	1 073	1206
75.0	13.4	14.4	48.1	86.8	127	211	298	342	431	521	612	795	934	1 314	1 3 5 4
50.0	29.3	34.7	83.9	134	184	284	383	433	533	633	733	933	1 083	1 383	1 5 3 3
25.0	50.0	69.3	135	196	256	371	484	540	651	761	870	1 087	1 248	1 568	1728
10.0	68.4	115	195	2 6 6	334	464	589	650	770	889	1 006	1 23 8	1 4 0 9	1 748	1 916
5.0	77.6	150	237	315	388	526	657	722	848	972	1 094	1 334	1 512	1 862	2 035
1.0	90.0	230	332	420	502	655	800	870	1 007	1 141	1 272	1 529	1 718	2 088	2 270
	-	\sim	40	65	100	150	X	250		400		650		1 000	\searrow

NOTE-Binomial distribution used for percent defective computations; Poisson for defects per hundred units.

IS: 10673 - 19

TABLE 10-A-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER A
(Clause 11-1)

	CUMU-						ACCE	ТАВ	LE	QUALIT	YLEVE	ELS (NO	RMAL	INSPEC	TION)						сими-
TYPE OF SAMPLING	LATIVE SAMPLE	< 6.5	6.5	X	10	15	25		40	65	100	150	X	250	\times	400	\times	650	\times	1 000	SAMPL
PLAN	SIZE	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac f	e Ac	Re	Ac R	Ac R	e Ac R	Ac R	Ac Re	Ac Re	Ac Re	Ac R	z Ac Re	Ac Re	Ac F	SIZE
SINGLE	2	۵	0 1				1	2 2	3	3 4	5 6	7 8	8 9	10 11	12 13	14 15	18 19	21 22	27 26	30	31 2
DOUBLE		∇	*				(X)	1	* }	(*)	(*)	(*)	(*)	(*)	(*)	(*)	(*)	(*)	(*)	(*)	
			-	USE LETTER D		USE LETTER B															
AULTIPLE :		⊽	*				*	-	×	*	*	*	*	*	*	*	*	*	*	*	
		<10	\	10	15	25	40	-	 55	100	150		250		400		650		1000		
		70		L.''	13	L				QUALIT	1	JEIS LT	<u> </u>	D INSE	<u> </u>				1,000		4

V = Use next subsequent sample size code letter for which acceptance and rejection numbers are available.

Ac = Acceptance number.

Re = Rejection number.

* = Use single sampling plan above l or alternatively use letter D).

(*)= Use single sampling (or alternativly use letter B).

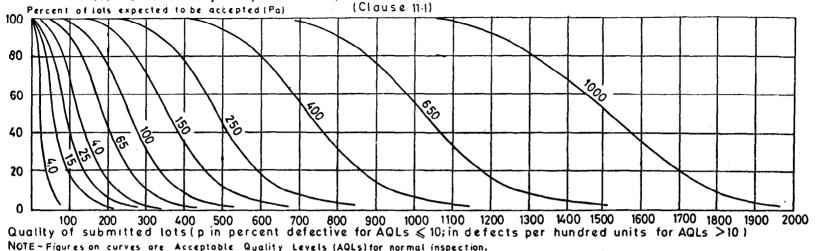


TABLE 10 B-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11-1)

			AC	CEPTABL	E QUALI	TY LEVEL	SINORMA	AL INSPE	CTION)								
P _a	4.0	4.0	- 15	25	40	65	100	\supset	150	\supset	250	\supset	400	\boxtimes	650	\times	1 000
	p (in Percent Defective)			p (in	Defects	per Hun	dred Units	s)									
99.0	0.33	0.34	4.97	14.5	27.4	59.5	96.9	117	159	203	249	345	419	573	651	947	1 0 29
95.0	1.70	1.71	11 - 8	27.3	45.5	87.1	133	157	206	256	308	415	496	663	748	1 065	1 152
90.0	3.45	3.50	17.7	36.7	58.2	105	155	181	234	288	343	456	541	716	804	1 131	1 2 2 2
75.0	9.14	9.60	32.0	57.6	84.5	141	199	228	287	347	408	530	623	809	903	1 249	1 344
50.0	20.6	23.1	55.9	89.1	122	189	256	289	356	422	489	622	722	922	1 022	1 389	1 489
25.0	37.0	46.2	89.8	131	170	247	323	360	434	507	580	724	832	1 046	1 152	1 539	1 644
10.0	53 6	76.8	130	177	223	309	392	433	514	593	671	825	939	1 165	1 .277	1 683	1 793
5.0	63.2	99.9	158	210	258	350	438	481	565	648	730	890	1 008	1 241	1 356	1 773	1 886
1.0	78.4	154	221	280	335	437	533	580	672	761	848	1 019	1 145	1 392	1 513	1 951	2 069
	6.5	6.5	25	40	65	100	> <	150	> <	250	> <	400	$\supset <$	650		1 000	
		•			Ac	ceptable	Quality I	Levels (Ti	ghtened i	nspection)		K				

NOTE-Binomial distribution used for percent defective computations; Poisson for defects per hundred units.

IS: 10673 - 1983

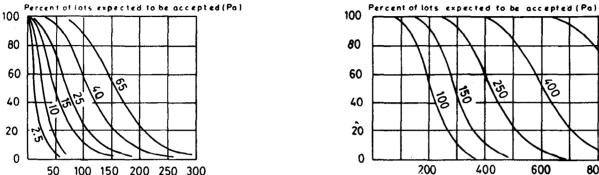
IABLE 10-B-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER B (Clause 11-1)

TYPE OF	сими~									A	CCEP	TABLE	QUALI	Y LEV	ELS (1	ORMA	٩L	INSPE	CTION)											сими-
	LATIVE SAMPLE	< 4.0		4.0	6	5.5	\times	10	15		25	40	65	100	\times	15	0	\supset	250	\supset		400	\triangleright	<	650		$\overline{\times}$	10	000	LATIV
PLAN	SIZE	Ac R	e A	c Re	Ac	Re	Ac R	Ac R	Ac	Re A	c Re	Ac R	e Ac R	Ac R	Ac R	e Ac	Re	Ac Re	Ac R	Ac F	₹e /	Ac Re	Ac	Re	Ac F	₹e /	Ac Re	Ac	Re	SIZE
SINGLE	3	⊽	0	1					1	2 2	3	3	5 (7 8	8	9 10	11	12 13	14 15	18	19 2	21 22	27	28	30	31 4	41 42	2 44	45	3
201101.5	2	∇ -		*					0	2 0	3	1 4	2 5	3 7	3	7 5	9	6 10	7 1	9	141	11 16	15	20	17 ;	22 2	23 29	25	31	2
DOUBLE	4				us		USE	USE	1	2 3	4	4 !	6 7	8 9	11 1	2 12	13	15 16	18 19	23	24	26 27	34	35	37 3	385	2 53	56	57	4
MULTIPLE		٧		*	A	ITER	D	C	++		++ ·	++	++	++	++	++		++	++	++		++	++		#		**	+	+	
		< 6.5		5.5	>		10	15	25		40	65	100	×	150	 >		250	×	400		\times	65	0	<u> </u>	1,	000	>		

- V = Use next subsequent sample size code letter for which acceptance and rejection numbers are available.
- Ac = Acceptance number.
- Re = Rejection number.
- * =Use single sampling plan above (or alternatively use letter E).
- # =Use double sampling plan above (or alternatively use letter D).

1200

TABLE 10 C TABLES FOR SAMPLE SIZE CODE LETTER C CHART C-Operating characteristic curves for single sampling plans (curves for double and multiple sampling are matched as closely as practicable). (Clause 11-1)



50 100 150 200 250 300 200 250 300 200 400 600 800 1000 Quality of submitted lots (p in percent defective for AQLs < 10; in defects per hundred units for AQLs > 10) NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection.

TABLE 10 C -1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11-1)

					ACCE	PTABL	E QUA	LITY LE	EVELS (NORMA	AL INSF	ECTION	43					
Pa	2.5	10	2.5	10	15	25	40	65	\boxtimes	100	X	150	\boxtimes	250	\times	400	\boxtimes	650
	Plin Pe Defec				<u> </u>	p (in De	fects p	er Hur	dred U	nits)	<u> </u>		<u> </u>		<i>V</i>		·	
99.0	0-20	3.28	0.20	2.89	8.72	16.5	35.7	58.1	70.1	95.4	122	150	207	251	344	391	568	618
95.0	1.02	7. 63	1.03	7.10	16.4	27.3	52.3	79.6	93.9	123	154	185	249	298	398	449	639	691
90.0	2.09	11. 2	2.10	10.6	22.0	34.9	63.0	93.1	109	140	173	206	273	325	429	482	679	733
75.0	5.59	19.4	5.76	19.2	34.5	50.7	84.4	119	137	172	208	245	318	374	485	542	749	806
50.0	12.9	31.4	13.9	33.6	53.5	73.4	113	153	173	213	253	293	373	433	553	613	833	893
25.0	24.2	45.4	27.7	53.9	78.4	102	148	194	216	260	304	348	435	499	627	691	923	987
10.0	36.9	58.4	46.1	77.8	106	134	186	235	260	308	356	403	495	564	699	766	1 010	1 0.7
5 • 0	45.1	65.8	59,9	94.9	126	155	210	263	289	339	389	438	534	605	745	814	1 064	1 131
1 .0	60.2	77.8	92.1	133	168	201	262	320	348	403	456	509	612	687	835	908	1 171	1; 24
	4.0	\sim	4.0	15	25	40	65	\supset	100	\sim	150	\times	250	\times	400	\sim	650	\supset

NOTE-Binomial distribution used for percent defective computations; Poisson for defects per hundred units.

TABLE 10-C-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER C (Clause 11.1)

TYPE OF	CUMU-							AC	CEPTAI	BLE QL	ALITY	LEVELS	NORM	AL INS	PECTION	1)							CUMU-
SAMPLING	LATIVE SAMPLE	< 2.5	2.5	4.0	\times	6.5	10	15	25	40	65	\times	100	\times	150	\geq	250	\times	400	\times	650	1000	LATIVE
PLAN		Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	
SINGLE	5	⊽	0 1		,		1 2	2 3	3 4	5 6	7 8	8 9	10 1	12 13	14 15	18 19	21 22	27 28	30 31	41 42	44 45		5
	3	V	*				0 2	0 3	1 4	2 5	3 7	3 7	5 9	6 10	7 11	9 14	11 16	15 20	17 22	23 29	25 31		3
DOUBLE	6			USE LETTER		USE LETTER	1 2	3 4	4 5	6 7	8 9	11 12	12 13	15 16	18 19	23 24	26 27	34 35	37 38	52 53	56 57	USE LETTER	6
MULTIPLE		٧	*	В	E		++	++	**	**	*	++	++	***	**	***	**	++	++	++	***	B	
		<4.0	4.0	×	6.5	10	15	25	40 CEPTAB	65	×	100	×	150	×	250	×	400	<u> </u>	650	×	1 000	

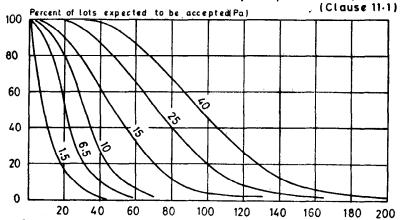
V = Use next subsequent sample size code letter for which acceptance and rejection numbers are available.

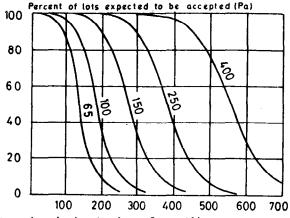
Ac = Acceptance number.

Re = Rejection number.

* = Use single sampling plan above (or alternatively use letter F).

+ = Use double sampling plan above (or alternatively use letter D).





Quality of submitted lots(p in percent defective for AQLs <10; in defects per hundred units for AQLs >10)

NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection.

TABLE 10D-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS
(Clause 11-1)

						10	ouse	: 11·1 <i>)</i>											
					ACCEP	TABLE	QUAL	ITY LE	VELS (N	IORMAL	INSPE	CTION			-				
Pa	1.5	6.5	10	1.5	6.5	10	15	25	40	$\supset \!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!$	65	$\supset <$	100	\supset	150	$\supset \subset$	250	\supset	400
	p (in (Percent Defec	tive)				lin De	efects	per Hur	ndred (Jnits)								
99.0	0.13	2.00	6.00	0.13	1.86	5.45	10 3	22.3	36.3	43.8	59.6	76.2	93.5	129	157	215	244	355	386
95.0	0.64	4.64	11.1	0.64	4.44	10.2	17.1	32.7	49.8	58.7	77.1	96.1	116	156	186	249	281	399	432
90.0	1.31	6.88	14.7	1. 31	6.65	13.8	21.8	39.4	58.2	67.9	87.8	108	129	171	203	268	301	424	458
75.0	3.53	12.1	22.1	3.60	12.0	21,6	31.7	52.7	74.5	85.5	108	130	153	199	234	303	339	46 8	504
50.0	8.30	20.1	32,1	8.66	21.0	33.4	45.9	70.9	95.9	108	133	158	183	233	271	346	383	521	558
25.0	15.9	30.3	43.3	17.3	33.7	49.0	63.9	92.8	121	135	163	190	218	272	312	392	432	577	617
10.0	25.0	40.6	53.9	28.8	48.6	66.5	83.5	116	147	162	193	222	252	309	352	437	478	631	672
5.0	31 - 2	47.1	59.9	37.5	59.3	78.7	96.9	131	164	180	212	243	274	334	378	465	509	665	707
1.0	43.8	58.8	70.7	57.6	63.0	105	126	164	200	218	252	285	318	382	429	522	568	732	776
	2.5	10		2.5	10	15	25	40	\supset	65	$\overline{}$	100	\supset	150	$\overline{\mathbf{x}}$	250	\times	400	\sim
				<u> </u>	Acces	otable (Quality	Levels	(Tighte	ned In	spectio	n)		·	<i>ك</i>				<u></u> 3

NOTE-Binomial distribution used for percent detective computations, Poisson for defects per hundred units.

TABLE 10-D-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER D

(Clause 11.1)

TYPE OF	CUMU -				-				ACC	CEPTAE	LE	QUAI	LITY (ΕV	ELS	NOR	МΔΙ	L INS	PEC	TION	}										сими-
SAMPLING	LATIVE SAMPLE	<1.5	1.5	2.5	\boxtimes	4.0	6.5	ī	10	15	2	5	40		$\overline{<}$	65	Ţ	$\overline{\times}$	100		$\overline{\times}$	150		abla	25	0	$\overline{\times}$	1	400	>400	LATIVE
PLAN		Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac I	Re A	Ac Re	Ac Re	Ac	Re	Ac Re	Ac	Re	Ac R	e A	Ac Re	Ac	Re A	c Re	Ac	Re Ac	Re	Ac	Re	Ac R	e Ad	: Re	Ac Re	SAMPLE SIZE
SINGLE	8	V	0 1				1	2	2 3	3 4	5	6	7 8	8	9	10	11/1	2 13	14	15 1	B 19	21	2227	28	30	31	41 4	2 44	45	Δ	8
DOUBLE	5	∇	*				0	2 () 3	1 4	2	5	3 7	3	7	5	9 6	10	7	119	14	11	16 15	20	17	22	23 2	9 25	31	Δ	5
	10						1	2 3	4	4 9	6	7	8 9	111	12	12 1	13 1	5 16	18	19 2	3 24	26	27 34	35	37	38	52 5	3 56	5 57	İ	10
	5	٧	*		USE LETTER	USE LETTER	#	2 7	# 2	# 3	*	4	0 4	0	4	0	5 0	6	1	71	8	2	9 3	10	4	12	6 1	5 6	16	Δ	2
	4						#	2 0) 3	0 3	h	5	1 6	2	7	3	8 3	9	4	10 6	12	7	14 10	17	11	19	6 2	5 17	27		4
	6						0	2 0) 3	1 4	2	6	3 8	4	9	6 1	10 7	12	8	13 11	17	13	19 17	24	19	27	26 3	6 29	39		6
MULTIPLE	8						0	3 1	4	2 5	3	7	5 10	6	11	8 1	3 10	0 15	12	17 16	3 22	19	25 24	31	27	34	37 4	6 40	49		8
	10						ı	3 2	2 4	3 6	5	8	7 11	9	12	11 1	15 14	4 17	17	20 2	2 25	25	29 32	37	36	40	49 5	5 53	58		10
`	12						,	3 3	5	4 6	7	9 1	0 12	12	14	14	17 1	8 20	21	232	7 29	31	33 40	43	45	47	51 6	4 65	68		12
	14			:			2	3 4	. 5	6 7	9	10	13 14	14	15	18 1	9 2	1 22	25	26 3	2 33	37 :	8 48	49	53	54	72 7	77	78		14
		< 2.5	2.5	X	4.0	6.5	10		15	25	4	0	\times	6	55	$\overline{\times}$	1	100	>		150	>	2	50	$\overline{>}$	<	400		<	> 400	
						*			ACCE	PTABL	E Q	UAL	ITY L	EVE	LS (TIGH	TEN	NED I	NSPE	ECTIO	(NC	-				L -					

 Δ_- = Use next preceding sample size code letter for which acceptance, and rejection numbers are available.

₹ = Use next subsequent sample size code letter for which acceptance and rejection numbers are available.

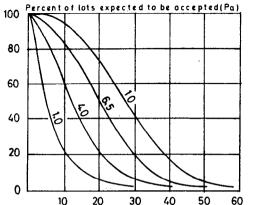
Ac = Acceptance number

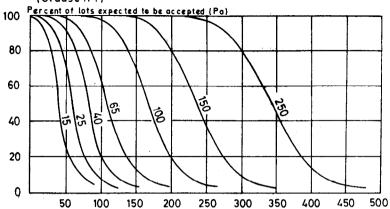
Re = Rejection number

* = Use single sampling plan above (or alternatively use letter G).

= Acceptance not permitted at this sample size.

TABLE 10 E TABLES FOR SAMPLE SIZE CODE LETTER E CHART E-Operating characteristic curves for single sampling plans(curves for double and multiple sampling are matched as closely as practicable) (Clause 11-1)





Quality of submitted lots(pin percent defective for AQLs ≤10; in defects per hundred units for AQLs >10)

NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection-

TABLE 10 E-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 111)

						· A	CEPTA	BLE Q	UALITY	LEVEL	S (NOR	MAL IN	SPECTIO	(NC						
Pa	1.0	4.0	6.5	10	1.0	4.0	6.5	10	15	25	\supset	40	$\supset <$	6.5	\supset	100	\bowtie	150	\boxtimes	250
	p (in Pe	rcent De	efective)			`p (in	Defe	cts per	Hundr	ed Uhit	s)								
99.0	0.077	1.19	3.63	7.00	0.078	1.15	3.35	6.33	13,7	22,4	27.0	36.7	46.9	57.5	79.5	96.7	132	150	219	238
95.0	0.394	2.81	6.63	11.3	0.395	2.73	6.29	10.5	20.1	30.6	36.1	47.5	59.2	71.1	95.7	115	153	173	246	266
90.0	0.807	4.16	8.80	14.2	0.808	4.09	8.48	13.4	24.2	35.8	41.8	54.0	66.5	79.2	105	12 5	165	185	261	282
75.0	2.19	7.41	13.4	19.9	2.22	7.39	13.3	19.5	32.5	45.8	52.6	66.3	80.2	94.1	122	144	187	208	288	310
50.0	5.19	12.6	20.0	27.5	5.33	12.9	20.6	28.2	43.6	59.0	66.7	82,1	97.5	113	144	168	213	236	321	344
25.0	10.1	19.4	28.0	36.2	10.7	20.7	30.2	39.3	57.1	74.5	83.1	100	117	134	167	192	241	266	355	379
10.0	16.2	26.8	36.0	44.4	17.7	29.9	40.9	51.4	71.3	90.5	100	119	137	155	190	217	269	295	388	414
5.0	20.6	31.6	41.0	49.5	23.0	36.5	48.4	59.6	80.9	101	111	130	150	168	205	233	286	313	409	435
1.0	29.8	41.5	50.6	58.7	35.4	51.1	64.7	77.3	101	123	134	155	176	196	23 5	264	321	349	450	477
	1.5	6.5	10	\sim	1.5	6.5	10	15	25	X	40	\times	65	\times	100	\times	150	\times	250	\supset

NOTE - Binomial distribution used for percent defective computations; Poisson for defects per hundred units-

TABLE 10-E-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER E (Clause 11:1)

	сими -								ACC	EPTAE	BLE Q	UALI	IY L	EVEL	s (i	NORM	AL	INSF	ECTIO	(NC											сими
	SAMPLE	< 1.0	1.0	1.5	\times	2.5	4.0		6.5	10	15	7	5	\times		4 0	\times	\leq	65		\times	100	>	<	150		\leq	25	50	>250	SAMPL
,	SIZE	Ac Re	Ac Re	Ac Re	Ac Re	Ac Re	Ac R	e Ac	c Re	Ac R	Ac R	g Ac	Re	Ac R	z At	Re	Ac	Re.	Ac R	Αc	Re	Ac R	e Ac	Re	Ac F	e Ac	Re	Αc	Re	Ac Re	SIZE
SINGLE	13	⊽	0 1				1 2	2 2	3	3 4	5 1	6 7	8	3 9	10	11	12	13	4 15	18	19	21 2	2 27	28	30	31 41	42	44	45	Δ	13
504515	8	۷					0	2 0	3	1 4	2	5 3	7	3 7	5	9	6	10	7 11	9	14	11 1	5 15	20	17 2	2 23	29	25	31	Δ	8
DOUBLE	16		*				,	2 3	4	4 5	6	7 8	9	11 12	12	13	15	16	8 19	23	24	26 2	7 34	35	37 3	8 52	53	56	57		16
	3	∇	*			USE LETTER F	#	2 #	2	# 3	# 4	4 0	4) 4	0	5	0	6 1	7	1	8	2	3	10	4 1	2 6	15	6	16	Δ	3
	6						#	2 0	3	о з	1 5	5 1	6	2 :	7 3	8	3	9	. 10	6	12	7 14	10	17	11 1	9 16	25	17	27		6
	9				ŕ		o :	2 0	3	1 4	2 (6 3	8 4		6	10	7	12	3 13	11	17	13 1	17	24	19 2	7 26	36	29	39		9
MULTIPLE	12						0	3 1	4	2 5	3	7 5	10	5 1	8	13	10	15 1	2 17	16	22	19 2	24	21	27 3	4 37	46	40	49		12
	15						1 :	3 2	4	3 6	5 8	8 7	11 9	12	11	15	14	17 1	7 20	22	25	25 2	32	37	36 [.] 4	0 49	55	53	58		15
	18						1	3 3	5	4 6	7 !	9 10	12 1	2 14	14	17	18 2	20 2	1 23	27	29	31 3	40	43	45 4	7 61	64	65	68		18
	21						2 :	3 4	5	6 7	9 10	13	14 1	4 15	18	19	21 2	22 2	5 26	32	33	37 31	48	49	53 · 5	4 72	73	77	78		21
		<1.5	1.5	X	2.5	4.0	6.5		10	15	25		<	40		<	65	1	$\overline{\times}$	10	00	$\overline{\times}$	15	0	$\overline{\times}$	2	50	\geq		>250	
								•	AC	CEPT	ABLE (QUA	LITY	LEVE	LS	(TIG	HTE	NEC	INS	PEC	CTION	1)									

 $[\]Delta$ = Use next preceding sample size code letter for which acceptance and rejection numbers are available

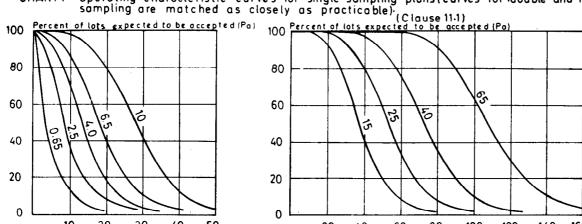
y = Use next subsequent sample size code letter for which acceptance and rejection numbers are available.

Ac = Acceptance number.

Re = Rejection number

 $[\]star$ = Use single sampling plan above.

^{# =} Acceptance not permitted at this simple 512e.



10 20 30 40 50 20 40 60 80 100 120 140 160 Quality of submitted lots (p in percent defective for AQLs \leq 10; in defects per hundred units for AQLs > 10) NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection

TABLE 10F -1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11.1)

·							(Claus	5e 11.1)									
					A	CCEPTABL	E QUALIT	Y LEVEL	S (NORMA	AL INSPEC	TION)					,	
Pa	0.65	2.5	4.0	6.5	10	0.65	2.5	4.0	6.5	10	15	$\supset <$	25	$\supset <$	40	$\supset <$	65
		p (in Pero	ent Defe	ctive)				p (in	Defects p	er Hundre	d Units)						
99.0	0.050	0.75	2.25	4.31	9.75	0.051	0.75	- 2.18	4.12	8.92	14.5	17.5	23.9	30.5	37.4	51.7	62.9
95.0	0 .256	1.80	4.22	7,13	14.0	0.257	1.78	4.09	6.83	13.1	19.9	23.5	30.8	38.5	46 . 2	62.2	74.5
90 . 0	0.525	2.69	5.64	9.03	16.6	0.527	2.66	5,51	8.73	15.8	23.3	27.2	35.1	43.2	51.5	68.4	81.2
75.0	1.43	4.81	8.70	12.8	21.6	1.44	4.81	8.68	12.7	21.1	29.8	34.2	43.1	52.1	61.2	79.5	93.4
50.0	3.41	8.25	13.1	18.1	27.9	3.47	8.39	13.4	18.4	28.4	38.3	43.3	53.3	63.3	73.3	93.3	108
25.0	6.70	12.9	18.7	24.2	34.8	6.93	13.5	19.6	25.5	37.1	48.4	54.0	65.1	76.1	87.0	109	125
10.0	10.9	18.1	24.5	30.4	41.5	11.5	19.5	26.6	33.4	46.4	58.9	65.0	77.0	88.9	101	124	141
5.0	13.9	21.6	28.3	34.4	45.6	15.0	23.7	31.5	38.8	52.6	65.7	72.2	84.8	97 . 2	109	133	151
1.0	20.6	28.9	35.6	42.0	53.4	23.0	33.2	42.0	50.2	65.5	80-0	87.0	101	114	127	153	172
	1.0	4.0	6.5	10	> <	1.0	4.0	6.5	10	15·	> <	25	$\supset \subset$	40	$\supset \subset$	65	\searrow
		L				Accep	table Qua	ality Leve	ls (Tighte	ned Inspec	tion)		_				

NOTE-Binomial distribution used for percent defective computations; Poisson for defects per hundred units

IS: 10673 - 1983

TABLE 10-F-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER F (Clause 11.1)

TYPE OF	CUMU-								A	CCE	PTABL	E G	UALITY	LE	VELS	NOR	MAL	INSF	PECT	ION)									сими
SAMPLING		<0.65	0	.65	1.	.0	> <	1.5	2.	. 5	4.0		6.5		10	1!	5	\setminus	\leq	25		\leq	4	0	X	\leq	65	>65	SAMP
	10176	Ac Re	Ac	Re	Αc	Re	Ac Re	Ac Re	Α¢	Re	Ac	Re	Ac Re	Ac	Re	Ac	Rε	Ac	Re	Ac R	2 A	Re	Αc	Re	Ac	Re	Ac Re	Ac Re	SIZE
SINGLE	20	∇	0	1					1	2	2	3	3 4	5	6	7	8	8	9	10 1	1 12	13	14	15	18	19	21 2:	Δ	20
	13	∇	,	×					0	2	o	3	i 4	2	5	3	7	3	7	5	9 6	10	7	11	9.	14	11 16	Δ	13
DOUBLE	26			_	USE	.	USE	USE	1	2	3	4	4 5	6	7	8	9	11	12	12 1	3 15	16	18	19	23	24	26 27		26
	5	Ø	,			TER		LETTER G	#	2	#	2	# 3	#	4	0	4	0	4	0	5 0	6	,	7	1	8	2 9	Δ	5
	10		Í		l				#	2	o	3	0 3	1	5	1	6	2	7	3	8 3	9	4	10	6	12	7 14	}	10
ĺ	15								0	2	0	3	1 4	2	6	3	8	4	9	6 1	0 7	12	8	13	11	17 1	13 19		15
MUTIPLE	20								0	3	1	4	2 5	3	7	5	10	6	11	8 1	3 10	15	12	17	16	22	19 25		20
]	25					1			1	3	2	4	3 6	5	8	7	11	9	12	11 1	5 14	17	17	20	22	25 2	5 29		25
	30				i				1	3	3	5	4 6	7	9	10	12	12	14	14 1	7 18	20	21	23	27	29	31 33		30
	35								2	3	4	5	6 7	9	10	13	14	14	15	18 19	21	22	25	26	32	33	37 38		35
		<1.0	1.	.0	\geq	<	1.5	2.5	4.1	0	6.5	\dashv	10		15	$\overline{>}$		2 9	5	$\overline{\times}$	1	40	>		6 5		\times	> 65	
	l				<u> </u>			·	A	CCE	PTABL	E	QUALITY	LE	VELS	(TIG)	HTEN	ĖD I	NSP	ECTION)							 	

Δ = Use next preceding sample size code letter for which acceptance and rejection numbers are available

 $ag{}$ — Use next subsequent sample size code letter for which acceptance and rejection numbers are available

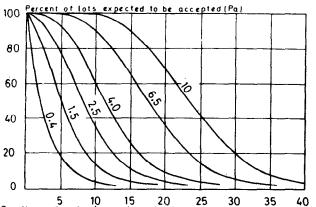
Ac = Acceptance number

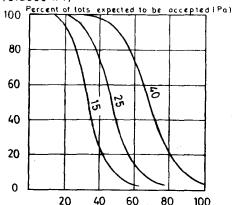
Rc = Rejection number

* = Use single sampling plan above for alternatively use letter U)

= Acceptance not permitted at this sample size.

TABLE 10 G TABLES FOR SAMPLE SIZE CODE LETTER G CHARTG-Operating characteristic curves for single sampling plans (curves for double and multiple sampling are matched as closely as practicable). (Clause 11 1)





5 10 15 20 25 30 35 40 20 40 60 80 100

Quality of submitted lots (p in percent defective for AQLs \(\left(10\); in defects per hundred units for AQLs > 10\)

NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection

TABLE 10 G-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS

								1 Ciuus	se III	<u></u>								
							ACCE	PTABLE	QUALI	TY LEVE	ELS (NO	RMAL IN	ISPECTION	ON)				
Pa	0.40	1.5	2.5	4.0	· 6.5	10	0.40	1.5	2.5	4.0	6.5	10	$\supset <$	15	$\supset <$	25	\supset	40
		P	lin Per	cent De	fective)					p(in [efects	per Hun	dred Ur	nits)				
99.0	0.032	0.475	1.38	2,63	5.94	9.75	0.032	0.466	1.36	2.57	5.57	9.08	11.0	14.9	19.1	23.4	32.3	39.3
95.0	0.161	1.13	2.59	4.39	8.50	13.1	0.160	1.10	2.55	4.26	8.16	12.4	14.7	19.3	24.0	28.9.	38.9	46.5
90 . 0	0.329	1.67	3.50	5.56	10.2	15.1	0.328	1.66	3.44	5.45	9.85	14.6	17.0	21.9	27.0	32.2	42.7	50.8
75.0	0.895	3.01	5.42	7.98	13.4	19.0	0.900	3.00	5.39	7.92	13.2	18.6	21.4	26.9	32.6	38.2	49.7	58.4
50.0	2.14	5.19	8.27	11.4	17.5	23.7	2.16	5.24	8.35	11 - 5	17.7	24.0	27.1	33.3	39.6	45.8	58 3	67
25.0	4.23	8.19	11.9	15.4	22.3	29.0	4.33	8.41	12.3	16.0	23.2	30-3	33.8	40.7	47 - 6	54.4	67.9	78.0
10.0	6.94	11.6	15.8	19.7	27.1	34.1	7.19	12.2	16.6	20.9	29.0	36.8	40.6	48.1	55.6	62.9	77.4	88.1
5.0	8.94	14.0	18-4	22.5	30.1	37.2	9.36	14.8	19.7	24.2	32.9	41.1	45.1	53.0	60.8	68.4	83 4	94.5
1.0	13.5	19.0	23.7	28.0	35.9	43.3	14.4	20.7	26-3	31.4	41.0	50.0	54.4	63.0	71.3	79.5	95.6	107
	0.65	2.5	4.0	6.5	10	> <	0.65	2.5	4.0	6.5	10		15	$\supset \subset$	25	\times	40	>

Acceptable Quality Levels (Tightened Inspection)

NOTE- Binomial distribution used for percent defective computations, Roisson for defects per hundred units.

TABLE 10 G-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER G
(Clause 11.1)

TYPE OF	CUMU -									ACC	ÈPTA	BL	QUAI	LITY	LEV	ELS	(NOF	RMAL	INSPE	C 7	(ION)									CUMU
SAMPLING		<0.40	1	0.40	0.6	5	> <	1.0	1	. 5	2.	5	4	0	6	. 5	10	0	> <	\int	15		\leq	25		X		40	>40	LATIV
		Ac R	εΔς	Re	Ac	Re	Ac Re	Ac Re	Αc	Re	Ac	Re	Αc	Re	Αc	Re	Αc	Re	Ac Re	2 Δ	c Re	Αc	Re	Δc	Re	Аc	Re	Ac R	Ac Re	SIZE
SINGLE	32	∇	0	1					,	2	2	3	3	4	5	6	7	8	6 9	10) 11	12	13	14	15	18	19	21 2	Δ	32
DOUBLE	20	٥		*					0	2	0	3	1	4	2	5	3	7	3 7	7 5	9	6	10	7	11	9	14	11 1	Δ	20
200866	40				USE			USE	1	2	3	4	4	5	6	7	8	9	11 12	12	13	15	16	18	19	23	24	26 27		40
	8	V	Ţ.	×	LETTE F	R	LETTER J	H	#	2	#	2	#	3	#	4	0	4	0 4	0	5	0	6	1	7	1	8	2 9	Δ	8
	16		1						#	2	0	3	0	3	1	5	1	6	2 7	7 3	8	3	9	4	10	6	12	7 14		16
	24								0	2	0	3	1	4	2	6	3	8	4 9	9 6	10	7	12	8	13	11	17	3 19		24
IULTIPLE	32								0	3	١	4	2	5	3	7	5	10	5 11	8	13	10	15	12	17	16	22	9 25		32
	40								1	3	2	4	3	6	5	8	7	11 9	9 12	11	15	14	17	17	20	22	25	25 29		40
	48					١			1	3	3	5	4	6	7	9	10	12 1	2 14	14	17	18	20	21	23	27 :	29	31 33		48
ļ	56								2	3	4	5	6	7	9	10	13	14 1	4 15	18	19	21	22	25	26	32	33	7 38		56
		< 0.65	0	.65	$\overline{>}$	1	10	1.5	2.	5	4.	0	6.	5	10)	$\overline{>}$	7	15		\times	2 5		$\overline{}$		40	\dagger	$\overline{}$	>40	

💻 Use next preceding sample size code letter for which acceptance and rejection numbers are available

🗸 Use next subsequent sample size code letter for which acceptance and rejection numbers are available

Ac = Acceptance number

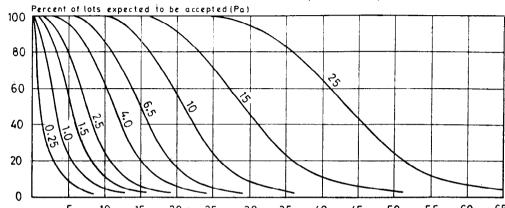
Re = Rejection 'nymber

* = Use single sampling plan above for alternatively use letter K)

= Acceptance not permitted at this sample size

CHART H-Operating characteristic curves for single sampling plans (curves for double and multiple sampling are matched as closely as practicable).

(Clause 11.1)



5 10 15 20 25 30 35 40 45 50 55 60 65

Quality of submitted lots (pin percent defective for AQLs ≤10; in defects per hundred units for AQLs >10)

NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection.

TABLE 10H-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11:1)

	.,		·					(Clau	SE 11:11											
							ACCE	PTABLE	QUALI	TY LEVE	ELS (NO	RMAL I	NSPECTI	ON)						
Pa	0.25	1.0	1.5	2.5	4.0	6.5	$\supset <$	10	0.25	1.0	1.5	2.5	4.0	6.5	\supset	10	\times	15	$\geq \leq$	25
			plin P	ercent	Defectiv	e)						P(in	Defect	s per	Hundred	Units)				
99.0	0.020	0.306	0.888	1.69	3.66	6.06	7.41	11.1	0.020	0.298	0.872	1.65	3.57	5-81	7.01	9.54	12.2	15.0	20.7	25.1
95.0	0.103	0-712	1.66	2.77	5.34	8.20	9.74	12.9	0.103	0.710	1.64	2.73	5.23	7.96	9.39	12.3	15.4	18-5	24.9	29.8
90.0	0.210	1-07	2.23	3.54	6-42	9-53	11.2	14.5	0-210	1.06	2.20	3.49	6.30	9.31	10.9	14.0	17.3	20.6	27.3	32.5
75.0	0.574	1.92	3.46	5-09	8.51	12-0	13-8	17.5	0.576	1-92	3.45	5.07	8.44	11.9	13.7	17.2	20.8	24.5	31 - 8	37-4
50.0	1.38	3.33	5.31	7.30	11-3	15-2	17-2	21.2	1.39	3.36	5.35	7-34	11.3	15-3	17.3	21.6	25.3	29.3	37.3	43.3
25.0	2.74	5.30	7.70	10.0	14.5	18-8	21.0	25.2	2.77	5.39	7.84	10.2	14.8	19.4	21:6	26.0	30-4	34.8	43.5	49.9
10-0	4.50	7.56	10.3	12.9	17.8	22.4	24.7	29.1	4.61	7-78	10.6	13-4	18-6	23.5	26.0	30.8	35.6	40-3	49.5	56.4
5-0	5.82	9.13	12.1	14.8	19.9	24.7	27.0	31.6	5.99	9.49	12.6	15.5	21.0	26.3	28-9	33.9	38.9	43.8	53.4	60.5
1.0	8.80	12.5	15.9	18.8	24-3	29•2	31-7	36.3	9.21	13.3	16.8	20.1	26.2	32.0	34.8	40.3	45.6	50.9	61.1	68.7
	0.40	1.5	2.5	4.0	6.5	>	10	$\overline{}$	0.40	1.5	2.5	4.0	6.5	\times	10	>	15	$\supset <$	25	\supset
		·		<u></u>	L	<u> </u>	A	ceptabl	le Qual	ty Leve	ts (Tigh	ntened 1	nspectio	on)	•	*				

NOTE- Binomial distribution used for percent defective computations; Poisson for defects per hundred units.

4

TABLE 10-H-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER H (Clause 11.1)

TYPE OF	сими-						ACC	EP	TABLE	E C	MALI.	ſΥ	LEVEL	S (NORM	AL.	INSF	PECT	ION)									CUMU-
SAMPLING	LATIVE SAMPLE	< 0.25	0.25	0.40	>	0.65	1.0)	1. !	5	2.5	T	4.0		5 • 5		eq	1)		\leq	19	5	\geq	/	2	5	> 25	LATIV SAMPL
PLAN	SIZE	Ac Re	Ac F	e Ac R	e Ac Re	Ac Re	Ac	Re	Ac	Re	Ac R	e /	Ac Re	Ac	Re	Ac	Re	Ac	Re	Ac	Re	Ac	Re	Ac	Re	Αc	Re	Ac Re	SIZE
SINGLE	50	∇	0	1			1	2	2	3	3	4	5 6	7	8	8	9	10	11	12	13	14	15	18	19	21	22	Δ	50
0011515	32	V	*	USE	USE	USE	0	2	0	3	1	4	2 5	3	7	3	7	5	9	6	10	7	11	9	14	11	16	Δ	32
DOUBLE	64			LETTE	RLETTER	LETTER	1	2	3	4	4	5 (5 7	8	9	11	12	12	13	15	16	18	19	23	24	26	27		64
	13	∇	*	G	K	(#	2	#	2	#	3 /	# 4	0	4	0	4	0	5	0	6	,	7	1	8	2	1 9	Δ	13
	26				}		#	2	o	3	o	3 1	5	,	6	2	7	3	8	3	9	4	10	6	12	7	14		26
	39				l		0	2	0	3	1	4	2 6	3	8	4	9	6	10	7	12	8	13	11	17	13	19		39
MULTIPLE	52						0	3	1	4	2	5 3	3 7	5	10	6	11	8	13	10	15	12	17	16	22	19	25		52
	65]	,	3	2	4	3	6 !	5 8	7	11	9	12	11	15	14	17	17	20	22	25	25	29		65
	78						1	3	3	5	4	6	7 9	10	12	12	14	14	17	18	20	21	23	27	29	31	33		78
	91						2	3	4	5	6	7 9	9 10	13	14	14	15	18	19	21	22	25	26	32	33	37	38		91
		< 0.40	0.4		0.65	1.0	1.5	,	2.5	;	4.0	1	6.5		<	1	0	\geq	<	15	,	>	<	25	5	>	<	> 25	
				1/	<u> </u>	/	ACCEF	'TA	BLE 0	LL AUG	LITY	l L E	/ELS	(TI	GHTE	NEC	או כ	SPE	 T I C	N)		I <u></u>		L		<u> </u>			

^{△ =} Use next preceding sample size code letter for which acceptance and rejection numbers are available.

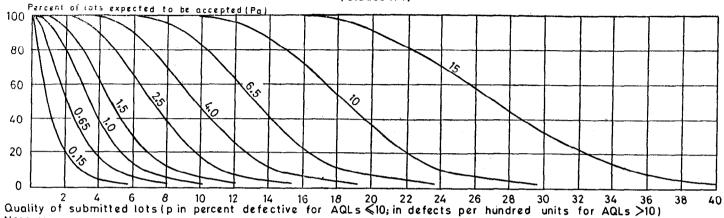
[₹] Use next subsequent sample size code letter for which acceptance and rejection numbers are available.

Ac - Acceptance number

Re = Rejection number.

^{¥ =} Use single sampling plan above (or alternatively use letter L).

^{# =} Acceptance not permitted at this sample size.



NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection.

TABLE 10 J-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11.1)

	1					· · · · · · · · · · · · · · · · · · ·		A C C S	PTABLE		177 151		20111						•			
		T	,	,				ACCE	FIABLE	UUAL	ITY LEV	VELS IN	ORMAL	INSPEC	TION)	·	ĸ	,	-			
Pa	0.15	0.65	1.0	1.5	2.5	4.0	><	65	> <	10	0.15	0.65	1.0	1.5	2.5	4.0	><	6.5	><	10	> <	15
				p (in F	ercent	Defecti	ve)								p (in De	fects p	er Hun	dred U	nitsl		* 3	·
99.0	0.013	0.188	0.550	1.05	2.30	3.72	4.50	6.13	7.88	9.75	0.013	0.186	0.545	1.03	2.23	3.63	4.38	5.96	7.62	9,35	12.9	15.7
95.0	0.064	0.444	1.03	1.73	3.32	5.06	5.98	7.91	9.89	11.9	0.064	0.444	1.02	1.71	3.27	4.98	5.87	7.71	9.61	11.6	15.6	18.6
90.0	0.132	0.666	1.38	2.20	3.98	5.91	6.91	8.95	11.0	13.2	0.131	0.665	1.38	2.18	3.94	5.82	6.79	8.78	10.8	12.9	17.1	20.3
75.0	0.359	1.202	2.16	3.18	5,30	7.50	8.62	10.9	13.2	15.5	0.360	1.20	2.16	3.17	5.27	7.45	8.55	10.8	13.0	15.3	19.9	23.4
50.0	0.863	2.09	3.33	4.57	7.06	9.55	10.8	13.3	15.8	18.3	0.866	2.10	3.34	4.59	7.09	9.59	10.8	13.3	15.8	18.3	23.3	27.1
25.0	1.72	3.33	4.84	6.31	9.14	11.9	13.3	16.0	18.6	21.3	1.73	3.37	4.90	6.39	9.28	12.1	13.5	16.3	19.0	21.8	27.2	31.2
10.0	2.84	4.78	6.52	8.16	11.3	14.2	15.7	18.6	21.4	24.2	2.88	4.86	6.65	8.35	11.6	14.7	16.2	19.3	22.2	25.2	30.9	35.2
5.0	3.68	5.80	7.66	9.39	12.7	15.8	17.3	20.3	23.2	26.0	3.75	5.93	7.87	6.69	13.1	16.4	18.0	21. 2	24.3	27.4	33.4	37.8
1.0	5.59	8.00	10.1	12.0	15.6	18.9	20.5	23.6	26.5	29.5	5.76	8.30	10.5	12.6	16.4	20.0	21.8	25.2	28.5	31.8	38.2	42.9
	0.25	1.0	1.5	2.5	4.0	>	6.5	$\overline{}$	10		0.25	1.0	1.5	2.5	4.5	\searrow	6.5	\searrow	10 .		15	\searrow
		1	<u> </u>	'		<u>~</u>	·	Acc	ceptable	Qualit	y Level	s (Tight	ened In	spectio	n)		<u> </u>	<u> </u>	4		<u></u>	

NOTE- Binomial distribution used for percent defective computations; Poisson for defects per hundred units.

48

TABLE 10-J-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER J

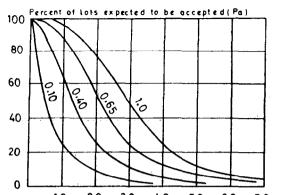
(Clause 11.1)

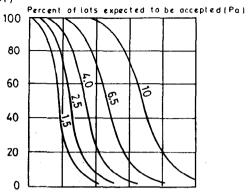
TYPE OF	CUMU-						ACCEPT	TAE	BLE QUA	AL	ITY LE	/EL (1	VOR	MAL	INS	PECTI	ON)					-						сими-
SAMPLING	LATIVE SAMPLE	< 0.15	0.15	0.25	> <	0.40	0 - 65	,	1-0	T	1.5	2.	5	4.	0	>		6.5	\Box	> <	7	10		>	\leq	1	5	> 15	LATIVE
PLAN	SIZE	Ac Re	Ac Re	AC RE	AC RE	Ac Re	A¢ R	ìe.	AC Re	4	c Re	Α¢	Rε	Α¢	Rε	Ac I	₹€	A¢ R	e	Ac R	ر ,	Ac R	e	Αc	Rε	Ac	Re	Ac R	
SINGLE	80	∇	0 1				1	2	2 3	3	4	5	6	7	8	8	9	10 1	1	12 13	,	4 1	5	18	19	21	22	Δ	80
DOUBLE	50 100	ᢦ	*				_	2 2		1 4	4 5	-	- 1	3 8		3 11	7		9		0 7		-1		14 24	1	16 27	۵	50 100
	20	∇	*	USE LETTER H	USE LETTER	USE LETTER K	#	2	# 2	#	÷ 3	#	4	0	4	0	4	0	5	0 6	5 1		7	1	8	2	9	Δ	20
	40			"	٠	·	#	2	0 3	0	3	1	5	1	6	2	7	3	8	3 9	9 4	1	0	6	12	7	14		40
	60						0	2) 3	1	4	2	6	3	8	4	9	6 1	0	7 12	2 8	1	3	11 .	17	13	19		60
MULTIPLE	80						0	3	1 4	2	5	3	7	5	10	6	11	8 1	3 1	10 15	5 1	2 1	7	16	22	19	25		80
	100						1	3 2	2 4	3	6	5	8	7	11	9	12	11 1	5 1	14 17	,	7 2	0	22	25	25	29		100
	120						1	3 3	5	4	6	7	9	10	12	12	14	14 1	7	18 20	2	1 2	3	27	29	31	33		120
i	140						2	3 4	5	6	7	9	10	13	14	14	15	18、 1	9/2	21 22	2 2	5 2	6	32	33	37	38		140
		< 0.25	0.25	\times	0.40	0.5	1-0	†	1.5	T	2.5	4.0		$\overline{>}$	1	6.5	1	$\overline{\times}$	1	10	t	$\overline{\mathbf{x}}$	1	15		\geq		>15	
						A	CCEPT	AΒ	LE QUA	\LI	TY LE	ELS	TIC	SHTE	NEC	INSF	EÇ	(NOT			•		•	,					1

- Δ = Use next preceding sample size code letter for which acceptance and rejection numbers are available.
- V = Use next subsquent sample size code letter for which acceptance and rejection numbers are available.
- Ac = Acceptance number.
- Re = Rejection number.
- * = Use single sampling plan above (or alternatively use letter M).
- # = Acceptance not permitted at this sample size.

CHART K-Operating characteristic curves for single sampling plans (Curves for single and multiple sampling are matched as closely as practicable).

(Clause 11-1)





1.0 2.0 3.0 4.0 5.0 6.0 7.0 Quality of submitted lots (p in percent defective for AQLs < 10; in defects per hundred units for AQLs >10) NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection

TABLE 10K-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11.1)

							3 11 - 1 1					
					CCEPTABL	E QUALITY	LEVELSIN	ORMAL INS	PECTION)			
Pa	0.10	0.40	0.65	1.0	1.5	2.5	$\supset <$	4.0	$\supset <$	6.5	><	10
	-			pl	in Percent	Defective	or Defect	s per Hund	dred Units			***************************************
99.0	0.0081	0,119	0.349	0.658	1.43	2.33	2.81	3,82	4.88	5.98	8.28	10.1
95.0	0.0410	0.284	0.654	1.09	2.09	3.19	3.76	4.94	6.15	7.40	9.95	11.9
90.0	0.0840	0.426	0.882	1,40	2.52	3.73	4,35	5,62	6.92	8.24	10.9	13.0
75.0	0.230	0.769	1.382	2.03	3.38	4.77	5.47	6.90	8.34	9.79	12.7	14.9
50.0	0.554	1.34	2.14	2.94	4.54	6.14	6.94	8.53	10.1	11.7	14.9	17.3
25.0	1,11	2.15	3.14	4.09	5.94	7.75	8.64	10,4	12.2	13.9	17.4	20.0
10.0	1.84	3.11	4.26	5.35	7, 42	9.42	10.4	12.3	14.2	16.1	19.8	22.5
5.0	2.40	3.80	5.04	6.20	8.41	10.5	11.5	13.6	15.6	17.5	21.4	24.2
1.0	3.68	5.31	6.73	8.04	10.5	12.8	18.3	16.1	18.3	20.4	24.5	27.5
	0.15	0.65	1.0	1.5	2.5		4.0		6.5		10	

NOTE- All values given in above table based on Poisson distribution as an approximation to the Binomial

TABLE 10-K-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER K (Clause:11.1)

TYPE OF	сими-		· · · · · · · · · · · · · · · · · · ·			AC	CEPT	ABI	E Q	UAI	LITY	LEV	ELS (ИО	RMA	LIN	SPI	EC TIO	(۱		•	-						сими-
SAMPLING	LATIVE SAMPLE	<0.10	0.10	0.15	X	0.25	0.4	0	0.65	1	1.0	T	1.5	2	.5	\geq	<	4.0	Ī	$\overline{\times}$	6	.5		abla	ı	0	>10	SAMPLE
PLAN	SIZE	Ac Re	Ac R	Ac Re	Ac Re	Ac Re	Ac I	Re A	Ac R	e A	Ac F	e A	c Re	Ac	Re	Ac	Re	Ac R	e	Ac Re	Ac	Re	Ac	Re	Αc	Re	Ac Re	SIZE
SINGLE	125	∇	0 1				1	2 2	?	3 3	1	45	6	7	8	8	9	10	וווו	2 13	14	15	18	19	21	52	Δ	125
	80	. ∇	*	USE	USE	USE	o	2 0)	3 1	-	42	5	3	7	3	7	5	9 6	5 10	7	11	9	14	11	16	Δ	80
DOUBLE	160			LETTER J	LETTER M	LETTER L	1	2 3		44		5 6	7	8	9	n	12	12 1	3 1	5 16	18	19	23	24	26	27		160
	32	7	*				#	2	#	2 =	#	3 7	k 4	0	4	0	4	0	50) 6	1	7	,	8	2	9	Δ	32
	64						#	2 0		3 0		3 1	5	h	6	2	7	3	8	3 9	4	10	6	12	7	14		64
	96						0	2 0)	3 1		4 2	6	3	8	4	9	6 1	0 7	7 12	8	13	11	17	13	19		96
MULTIPLE	128						0	3 1		4 2		5 3	7	5	10	6	11	8 1	3 1	0 15	12	17	16	22	19	25		128
	160						1	3 2	: 4	4 3		6 5	8	7	11	9	12	11 1	5 1	4 17	17	20	22	25	25	29		160
	192						1	3 3	ı i	5 4		6 7	9	10	12	12	14	14 1	7/1	8 20	21	23	27	29	31	33		192
	224						2	3 4	. !	5 6		7 9	10	13	14	14	15	18 1	9/2	21 22	25	26	32	33	37	38		224
		<0.15	0.15	X	0.25	0.40	0.6	5	1,0		1.5		2.5	\geq	\leq	4.0	,	\times	1	6.5	\geq	<	10)	\geq	<	> 10	
						AC	CEPT	۱BL	E Q	UA	LITY	LE	VELS	(1)	GHT	ENE	11 0	NSPEC	TIC	(N)								

Δ = Use next preceding sample size code letter for which acceptance and rejection numbers are available.

Ac = Acceptance number.

Re = Rejection number.

* = Use single sampling plan above (or alternatively use letter N).

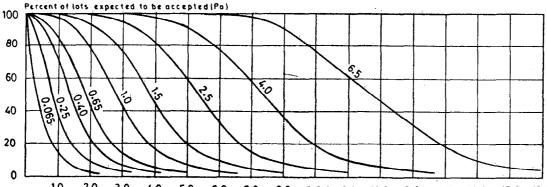
V = Use next subsequent sample size code letter for which acceptance and rejection numbers are available.

^{# =} Acceptance not permitted at this sample size.

TABLE 101 TABLES FOR SAMPLE SIZE CODE LETTER L

CHART L-Operating characteristic curves for single sampling plans(curves for double and multiple sampling are matched as closely as practicable).

(Clause 11·1)



1.0 2.0 3.0 4.0 5.0 6.0 7.0 8.0 9.0 10.0 11.0 12.0 13.0 14.0 15.0 16.0 Quality of submitted lots (p in percent defective for AQLs \leq 10; in defects per hundred units for AQLs > 10) NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection.

TABLE 10 L-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11-1)

				ACC	EPTABLE C	MALITY LE	EVELSINORI	MAL INSPE	CTION)			
Pa	0.065	0.25	0.40	0.65	1.0	1.5	$\supset <$	2.5	><	4.0	$\supset <$	6.5
				plin	Percent D	efective or	Defects pe	r Hundred	Units 1			
99.0	0.0051	0.075	0.218	0.412	0.893	1.45	1.75	2.39	3.05	3.74	5.17	6.29
95.0	0.0256	0.178	0.409	0.683	1.31	1.99	2.35	3.09	3.85	4.62	6.22	7.45
90.0	0.0525	0.266	0.551	0.873	1.58	2.33	2.72	3.51	4.32	5.15	6.84	8.12
75.0	0.144	0.481	0.864	1.27	2.11	2.98	3.42	4.31	5.21	6.1?	7.95	9,34
50.0	0.347	0.839	1.34	1.84	2.84	3.84	4.33	5.33	6.33	7. 33	9.33	10.8
25.0	0.693	1.35	1.96	2.56	3.71	4.84	5.40	6.51	7.61	8.70	10.9	12.5
10.0	1.15	1.95	2.66	3.34	4.64	5.89	6.50	7.70	8.89	10.1	12.4	14,1
5.0	1.50	2.37	3.15	3.88	5.26	6.57	7. 22	8.48	9.72	10.9	13.3	15.1
1.0	2.30	2.32	4.20	5.02	6.55	8.00	8.70	10.1	11.4	12.7	15.3	17.2
	0.10	0.40	0.65	1.0	1.5	\sim	2.5		4.0	$\overline{}$	6.5	$\uparrow >$

NOTE-All values given in above table based on Poisson distribution as an approximation to the Binomial.

Ñ

IS: 10673 - 1983

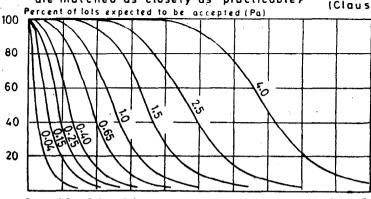
TABLE 10-L-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER L (Clause: 11.1)

TYPE OF	сими-					AC	CEP	ĪΑ	BLE	Q	UAL	ITY	LEV	/EL	S (1	106	МА	LII	NSP	EC1	ION									CUMU-
SAMPLING PLAN		<0.065	0.065	0.10	X	0.15	0.2	-5	0.4	0	0.6	5	1.0	0	1.5	,	>	<	2.	5	>		4.0		>	<	6	.5	>6.5	SAMPLE
	SIZE	Ac Re	Ac R	Ac Re	Ac Re	Ac Re	Ac	Re	Ac i	₹e	Ac	Re	Ac	Re	Αc	Ré	Ac	Re	Αc	Re	Ac f	₹e	Ac R	e	Αċ	Re	Αc	Re	Ac Re	SIZE
SINGLE	200	۷	0 1				1	2	2	3	3	4	5	6	7	8	8	9	10	11	12 1	3	4 1	5	18	19	21	22	Δ	200
	125						0	2	0	3	1	4	2	5	3	7	3	7	5	9	6 1	0	7 1	1	9	14	11	16	Δ	125
DOUBLE	250	₹	*	USE LETTER K		USE LETTER	1	2	3	4	4	5	6	7	8	9	11	12	12	13	1 5 1	6	8 1	9	23	24	26	27		250
	50	∇	*				#	2	#	2	#	3	#	4	0	4	0	4	0	5	0	61	-	7	1	8	2	9	Δ	50
	100						#	2	0	3	0	3	1	5	1	6	2	7	3	8	3	9	4 1	۰	6	12	7	14		100
	150						0	2	0.	3	1	4	2	6	3	8	4	9	6	10	7 1	2	8 1	3	11	17	13	19		150
MULTIPLE	200			1			0	3	1	4	2	5	3	7	5	10	6	11	8	13	10	15	2 1	7 1	6	22	19.	25		200
	250	. •]	1	3	2	4	3	6	5	8	7	11	9	12	11	15	14 1	7 1	7 2	0	22	25	25	29		250
	300						1	3	3	5	4	6	7	9	10	12	12	14	14	17	18 2	20	21 2	3	27	29	31	33		300
	350						2	3	4	5	6	7	9	10	13	14	14	15	18	19	21 2	2 2	25 2	6	32	33	37	38		350
		<0 .10	0.10	×	0.15	0.25	0.4	0	0.65	5	1.0	,	1.5		\geq		2.	5	\geq	\leq	4.0	1	<u></u>		6.5	5		<	>6.5	
					,	AC	CEP	TA	BLE	Q	UAL	ITY	LE	VEL	S (T	IGH	TEN	EC	INS	PE	CTIO	N)								

- Use next preceding sample size code letter for which acceptance and rejection numbers are available.
- V Use next subsequent sample size code letter for which acceptance and rejection numbers are available.
- Ac Acceptance number,
- Rc Rejection number.
- * Use single sampling plan above (or alternatively use letter P).
- # Acceptance not permitted at this sample size.



TABLE 10M TABLES FOR SAMPLE SIZE CODE LETTER M
CHART M-Operating characteristic curves for single sampling plans (curves for double and multiple sampling are matched as closely as practicable)
(Clause 11-1)



0 1.0 2.0 3.0 4.0 5.0 6.0 7.0 8.0 9.0 10.0 Quality of submitted lots(p in percent defective for AQLs \leq 10; in defects per hundred units for AQLs > 10) NOTE-Figures on curves are Acceptable Quality Levels(AQLs) for normal inspection

TABLE 10 M-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11:1)

	j			AC	CEPTABLE (QUALITY LE	VELS (NO	RMAL INSPI	ECTION)			
Pa	0.040	0.15	0.25	0.40	0.65	1.0	> <	1.5	$\triangleright <$	2.5	><	4.0
		-		plin	Percent Def	ective or D	efects per	Hundred I	Units)			
99.0	0.0032	0.047	0,138	0.261	0.566	0.922	1,11	1.51	1.94	2.38	3.28	3.99
95.0	0.0163	0.112	0.259	0.433	0.289	1.26	1.49	1.96	2.44	2.94	3.95	4 73
90.0	0.0333	0,168	0.349	0.533	1.00	1.48	1.72	2.23	2.75	3.27	4.34	5.16
75.0	0.0914	0.305	0.580	0.804	1,34	1.89	2.17	2.74	3.31	3.89	5 05	5 93
50.0	0.220	0.532	0.848	1.17	1.80	2 43	2.75	3.39	4.02	4.66	5.93	6.88
25.0	0.440	0.854	1.24	1.62	2.36	3.07	3.43	4.13	4.83	5.52	6,90	7.92
10.0	0.731	1.23	1.69	2.12	2.94	3.74	4.13	4.89	5.65	6.39	7.86	8.95
5.0	0.951	1.51	2.00	2.46	3.34	4.17	4.58	5.38	6.17	6.95	8.47	9.60
1,0	1.46	2.11	2.67	3.19	4.16	5.08	5.53	6.40	7.25	8.08	9.71	10.9
	0.065	0.25	0.40	0.65	1.0		1.5		2.5		4.0	\sim

NOTE-All values given in above table based on Poisson distribution as an approximation to the Binomial.

TABLE 10-M-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER M (Clause: 11.1)

	CUMU-								ACC	EP1	TABL	.E	QUA	LIT	ΥL	E۷	ELS	{N	IORM	4 A L	. IN	SPE	CTI	0 N)								сими-
	SAMPLE	<0.04	0	0.0	40	0.065	,	> <	0.10	0	.15	0	.25	0	.40	0	.65	1	.0		$\overline{<}$	1.	5		<	2	.5		<	4	.0	>40	SAMPL
	SIZE	Ac F	≀e	Ac	Re	Ac F	Re A	Ac Re	Ac R	Z A C	c R	e A	Re	Ac	Re	A	Re	Αc	Re	Ac	: Re	Ac	Re	Ac	Re	Ac	Re	Αc	R	Αc	Re	Ac R	SIZE
SINGLE	315	∇		0	1					1	2	2	3	3	4	5	6	7	8	8	9	10	11	12	13	14	15	18	19	21	22	Δ	315
DOUBLE	200	∇	+	×	-					0	2	0	3	1	4	2	5	3	7	3	7	5	9	6	10	7	11	9	14	11	16	Δ	200
	400					USE LETTE		JSE ETTER	USE LETTER	,	2	3	4	4	5	6	7	8	9	11	12	12	13	15	15	18	19	23	24	26	27		400
	80	V		*		L	1	P	N	#	2	#	2	#	3	#	4	0	4	0	4	o	5	0	6	1	7	1	8	2	9	Δ	80
	160		l							#	2	0	3	0	3	1	5	1	5	2	7	3	8	3	9	4	10	6	12	7	14		160
ŀ	240									0	2	0	3	1	4	2	6	3	8	4	9	6	10	7	12	8	13	11	17	13	19		240
MALTIPLE	320									0	3	1	4	2	5	3	7	5	10	6	11	8	13	10	15	12	17	16	22	19	25	-	320
	400									,	3	2	4	3	6	5	8	7	11	9	12	11	15	14	17	17	20	22	25	25	29		400
	480									,	3	3	5	ż	6	7	9	10	12	12	14	14	17	18	20	21	23	27	29	31	33		480
	560									2	3	4	5	6	7	9	10	13	14	14	15	18	19	21	22	25	26	32	33	37	38		560
<u> </u>		<0.06	5 (0.0	65	\times	1	0.10	0.15	0.	25	0	40	0.	65	1	0	>	<	1.	5	\geq	<	2.	5	\geq	<	4.	0	\wedge	\leq	>4.0	
									ACCE	PT,	ABL	E (JUAL	ITY	/ LE	VΕ	LS (TIG	HTE	NE	או כ	SPE	CTI	ON)								

A = Use next preceding sample size code letter for which acceptance and rejection numbers are available

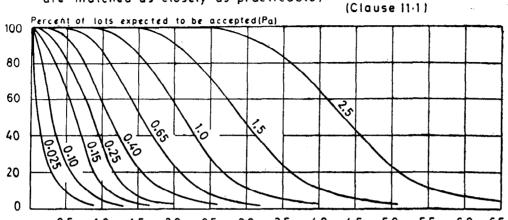
V = Use next subsequent sample size code letter for which acceptance and rejection numbers are available

Ac = Acceptance number

Re = Rejection number

* = Use single sampling plan above (or alternatively use letter 0 ic

= Acceptance not permitted at this sampl size



0.5 1.0 1.5 2.0 2.5 3.0 3.5 4.0 4.5 5.0 5.5 6.0 6.5 Quality of submitted lots (p in percent defective for AQLs \leq 10; in defects per hundred units for AQLs > 10) NOTE-Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection.

TABLE 10 N-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS (Clause 11-1)

					\	Clause 1	1-1/					
'					ACCEPTA	ABLE QUAL	ITY LEVEL	S (NORMAL	INSPECTIO	ON)		
Pa	0.025	0.10	0.15	0.25	0.40	0.65		1.0		1.5	$\supset <$	2.5
					plin Pe	rcent Defe	ctive or De	fects per b	lundred Ur	its)		······································
99.0	0.0020	0.030	0.087	0.165	0.357	0.581	0.701	0,954	1.22	1.50	2.07	2.51
95.0	0.0103	0.071	0.164	0.273	0.523	0.796	0.939	1.23	1.54	1.85	2.49	2.98
90.0	0.0210	0.106	0.220	0.349	0.630	0.931	1.09	1.40	1.73	2.06	2.73	3.25
75.0	0.0576	0.192	0.345	0.507	0.844	1.19	1,37	1.72	2.08	2.45	3.18	3.74
50.0	0.139	0.336	0.535	0.734	1,13	1,53	1.73	2.13	2.53	2.93	3.73	4.33
25.0	0.277	0.539	0.784	1.02	1.48	1.94	2.16	2.60	3.04	3.48	4.35	4.99
10.0	0.461	0.778	1.06	1.34	1,86	2.35	2.60	3.08	3.56	4.03	4.95	5.64
5.0	0.599	0.949	1.26	1,55	2,10	2.63	2.89	3.39	3.89	4.38	5.34	6.05
1.0	0.921	1 328	1.68	2.01	2.62	3,20	3.48	4.03	4.56	5.09	6.12	6.87
	0.040	0 15	0.25	0.40	0.65		1.0		1.5		2.5	

NOTE - All values given in above table based on Poisson distribution as an approximation to the Binomial.

IS: 10673 - 1983

TABLE 10-N-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER N (Clause:11.1)

TYPE OF	сими-					А	CCE	PT	ABLE	G	UAL	ITY	ĹEV	EL	S (NO	ORM	IAL	INS	SPE	CTI	ON)								сими-
SAMPLING	LATIVE SAMPLE	< 0.025	0.025	0.040	X	0.065	0.	·10	0.	15	0.29	5	0.40		0.65	>	<	1-	0		$\overline{<}$	1.	5		$\overline{<}$	2	.5	> 2.5	L ATIVI SAMPL
PLAN	SIZE	Ac Re	Ac Re	Ac R	e Ac Re	Ac Re	Ac	Re	Ac	Re	Ac	Re	Ac R	eΑ	c Re	Ac	Re	Ac	Re	Ac	Re	Ac	Re	Ac	Re	Ac	Re	Ac Re	SIZE
SINGLE	500	∇	0 1				,	2	2	3	3	4	5 6	7	8	В	9	10	11	12	13	14	15	18	19	21	22	Δ	500
DOUBLE	315	V	*	USE	USE	USE	0	2	0	3	1	4	2 5	3	7	3	7	5	9	6	10	7	11	9	14	11	16	Δ	315
	630			LETTE	LETTER	LETTER	,	2	3	4	4	5	6 7	8	9	11	12	12	13	15	16	18	19	23	24	26	27	1	630
	125	V	*	М	a	Р	#	2	#	2	#	3	# 4	0	4	0	4	0	5	0	6	1	7	1	8	2	9	Δ	125
	250						#	2	o	3	0	3	1 5	1	6	2	7	3	8	3	9	4	10	6	12	7	14		250
	375						0	2	О	3	1	4	2 6	3	8	4	9	6	10	7	12	В	13	11	17	13	19		375
MULTIPLE	500						0	3	7	4	2	5	3 7	5	10	6	11	8	13	10	15	12	17	16	22	19	25		500
	625						1	3	2	4	3	6	5 8	7	11	9	12	11	15	14	17	17	20	22	25	25	29		625
	750						i	3	3	5	4	6	7 9	10	12	12	14	14	17	18	20	21	23	27	29	31	33		750
	875						2	3	4	5	6	7	9 10) 1:	3 14	14	15	18	19	21	22	25	26	32	33	37	38		875
	<u></u>	< 0.040	0-040	>	0.065	0.10	0.	15	0.2	25	0.41	0	0-65	t	\times	1	٠0	\geq	<	1	·5	>	<	2	•5	>	<	> 2.5	
			ACCEPTABLE QUALITY LEVELS (TIGHTENED INSPECTION)																										

 $\Delta=$ Use next preceding sample size code letter for which acceptance and rejection numbers are available.

 ∇ = Use next subsequent sample size code letter for which acceptance and rejection numbers are available.

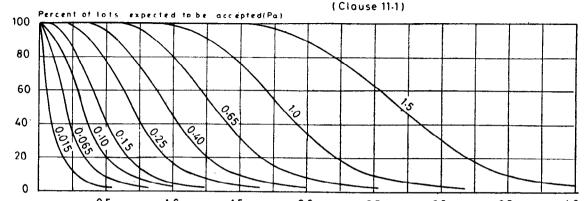
Ac = Acceptance number.

Re = Rejection number.

* = Use single sampling plan above (or alternatively use letter R).

= Acceptance not permitted at this sample size.

CHART P-Operating characteristic curves for single sampling plans(curves for double and multiple sampling are matched as closely as practicable)



0.5 1.0 1.5 2.0 2.5 3.0 3.5 4.0 Quality of submitted lots(p in percent defective for AQLs < 10; in defects per hundred units for AQLs > 10; NOTE-Figures on curves are Acceptable Quality Levels(AQLs) for normal inspection

TABLE 10 P-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS

(Clause 11-1)

				ACC	EPTABLE	QUALITY LE	VELS INOF	RMAL INSPI	ECTION)			
Pa	0.015	0.065	0.10	0.15	0.25	0.40		0.65		1.0		1.5
				p{in	Percent D	efective or	Defects p	er Hundred	Units)	·		
99.0	0.0013	0.0186	0.055	0.103	0.223	0.363	0.438	0.596	0.762	0.935	1.29	1.57
95.0	0.0064	0.0444	0.102	0.171	0.327	0.498	0.587	0.771	0.961	1.16	1.56	1.80
90.0	0.0131	0.0665	0.138	0.218	0.394	0.582	0.679	0.878	1.08	1.29	1.71	2.0
75.0	0.0360	0.120	0.216	0.317	0.527	0.745	0.855	1.08	1.30	1.53	1.99	2.3
50.0	0.0866	0.210	0.334	0.459	0.709	0.959	1.08	1.33	1.58	1.83	2.33	2.7
25.0	0.173	0.337	0.490	0.639	0.928	1. 21	1.35	1.63	1.90	2.18	2,72	3.1
10.0	0.288	0.486	0.665	0.835	1.16	1.47	1.62	1.93	2.22	2.52	3.09	3.5
5.0	0.375	0.593	0.787	0.969	1.31	1.64	1.80	2.12	2.43	2.74	3.34	3.7
1.0	0.576	0.830	1.05	1.26	1.64	2.00	2.18	2.52	2.85	3.18	3.82	4.2
	0.025	0.10	0.15	0.25	0.40		0.65		1.0		1.5	

NOTE-All values given in above table based on Poisson distribution as an approximation to the Binomial

8

TABLE 10-P-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER P

(Clause: 11.1)

TYPE OF	CUMU-					-	ACCEPT	ABL	E	UAI	LIT	Y LE	VΕ	LS	(NO	RM	ΑL	INS	PEC	TION	1)									CUMU-
S A MPLING PLAN	SAMPLE	0.010	0.	015	0.025	\times	0.040	0.0	65	0.1	0	0.1	5	0.	25	0.4	40		eg	0.6	5	>		1.0		>		1.5	>1.5	SAMPL
	SIZE	Ac R	Ac	Re	Ac Re	Ac Re	Ac Re	Ac	Re	Ac	Re	Αc	Re	Αc	Re	Αc	Re	Ac	Re	Ac	Re	Ac F	₹e	Ac F	₹e	Ac R	e A	Re	Ac Re	SIZE
SINGLE	800	V	0	1				,	2	2	3	3	4	5	6	7	8	8	9	10	11	12 1	3	14 1	15	18 1	21	22	Δ	800
DOUBLE	500	V						0	2	0	3	1	4	2	5	3	7	3	7	5	9	6	10	7 1	,,	9 1	11	16	Δ	500
DOOBLE	1000		*		USE	USE	USE	1	2	3	4	4	5	6	7	8	9	11	12	12	13	15 1	6	8 1	9	23 2	26	27		1 000
	200	7	+	+	LE TTER N	R	LETTER Q	#	2	#	2	#	3	#	4	0	4	o	4	0	5	0	6]	7	1 (2	9	Δ	200
	400							#	2	0	3	0	3	1	5	1	6	2	7	3	8	3	9	. 1	0	6 12	7	14		400
	600							0	2	0	3	1	4	2	6	3	8	4	9	6	10	7	2	3 1	3	11 13	13	19		600
MULTIPLE	800							0	3	1	4	2	5	3	7	5	10	6	"	8	13	10 1	5 1	2 1	7	16 22	19	25		800
[1 000							1	3	2	4	3	6	5	8	7	11	9	12	11	15	14 1	7 1	7 2	0	22 29	25	29		1 000
	1 200							1	3	3	5	4	6	7	9	10	12	12	14	14	17	18 2	0 2	1 2	3	27 2 9	31	33		1 200
İ	1 400							2	3	4	5	6	7	9	10	13	14	14	15	18	19	21 2	2 2	5 26	6 :	32 33	37	38		1 400
		<0.025	0.0	25	\times	0.040	0.065	0-1	0	0.15	,	0 2	5	0.4		$\overline{>}$	4	0.6	5	$\overline{}$	7	1.0	+	$\overline{}$	1	1.5		<	>1.5	
						ACCE	PTABLE	Qι	JAL	ITY	LEV	/ELS	; (T	IGH	TEN	ED	INS	SPE	CTI	(NC			<u>-1</u> -							

 Δ = Use next preceding sample size code letter for which acceptance and rejection numbers are available

V 😑 Use next subsequent sample size code letter for which acceptance and rejection numbers are available.

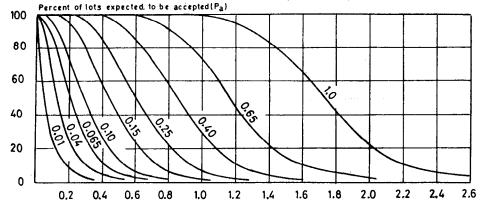
Ac = Acceptance number.

Re = Rejection number

* = Use single sampling plan above.

= Acceptance not permitted at this simple size.

(Clause 11.1)



Quality of submitted lots (p in percent defective for AQLs \leq 10; in defects per hundred units for AQLs > 10) NOTE- Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection.

TABLE 10 Q-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS
(Clause 11-1)

					(Claus	e 11.1)						
				ACCEPT	ABLE QU	ALITY LEVE	LS (NORM	AL INSPEC	(NOI)			
Pa	0.010	0.040	0.065	0.10	0.15	0.25	><	0.40	><	0.65	><	1.0
_			p (in Percer	t Defective	or Detects	per Hundred	Units)					
99.0	0.00081	0.0119	0.0349	0.0656	0.143	0 . 232	0.281	0.382	0.488	0.598	0.828	1.01
95.0	0.00410	0.0284	0.0654	0.109	0.209	0.318	0.376	0.494	0.615	0.740	0.995	1.19
90.0	0.00840	0.0426	0.0882	0.140	0.252	0.372	0.435	0.562	0.692	0.824	1.09	1.30
75.0	0.0230	0.0769	0.138	0.203	0.338	0.476	0.547	0.690	0.834	0.979	1.27	1.49
50.0	0.0554	0.134	0.214	0.294	0.454	0.614	0.694	0.853	1.01	1.17	1.49	1.73
25.0	0.111	0.215	0.314	0.409	0.594	0.775	0.864	1.04	1.22	1.39	1.74	2.00
10.0	0.184	0.310	0 426	0.534	0.742	0.942	1.04	1.23	1.42	1.61	1.98	2.25
5.0	0.240	0.380	0.504	0.620	0.841	1.05	1.15	1.36	1.56	1.75	2.14	2.42
1.0	0.368	0.531	0.672	0.804	1.05	1.28	1.83	1.61	1.83	2.04	2.45	2.75
	0.015	0.065	0.10	0.15	0.25	><	0.40	$\overline{}$	0.65	><	1.0	$>\!\!\!>$
			Acceptable	Quality Levi	els Mighten	ed Inspection	n)	×	•			

NOTE- All values given in above table based on Poisson distribution as an approximation to the binomial

TABLE 10-Q-2 SAMPLING PLANS FOR SAMPLE SIZE CODE LETTER Q (Clause: 11.1)

TYPE OF	CUMU-				· · · · · · · · · · · · · · · · · · ·	ACCE	PTABL	E	QUAL	ITΥ	LEV	ΈL	s (N	IOR	MAL	INS	PE	CTIO	N)										CUMU-
SAMPLING		\times	0.010	0.015	\boxtimes	0.025	0.040	0	0.065	0.	10	0	·15	0.	25		eg	0.	40	\geq	\leq	0-	65	$ \wedge $	\leq	1	0.	>1:0	LATIVE SAMPLE
	SIZE		Ac Re	Ac Re	Ac Re	Ac Re	Ac R	e A	c Re	Αc	Re	Ac	Re	Αc	Re	Αċ	Re	Ac	Re	Ac	Re	Ac	Re	Αc	Re	Αc	Re	Ac Re	SIZE
SINGLE	1 250		0 1				1 2	2 2	3	3	4	5	6	7	8	8	9	10	11	12	13	14	15	18	19	21	22	Δ	1 250
DOUBLE	800		*				0 2	2 0	3	1	4	2	5	3	7	3	7	5	9	6	10	7	11	9	14	11	16	Δ	800
DOOBLE	1 600	USE LETTER	''	USE LETTER	USE LETTER	USE LETTER		2 3	4	4	5	6	7	8	9	11	12	12	13	15	16	18	19	23	24	26	27		1600
	315	R	*	P	S	R	# 2	2 7	‡ 2	#	3	#	4	0	4	0	4	0	5	0	6	1	7	1	8	2	9	Δ	315
	630						# 2	20	3	0	3	1	5	1	6	2	7	3	8	3	9	4	10	6	12	7	14		630
	945						0 2	2 0	3	1	4	2	6	3	8	4	g	6	10	7	12	8	13	11	17	13	19		945
MULTIPLE	1 260						0 :	3 1	4	2	5	3	7	5	10	6	11	8	13	10	15	12	17	16	22	19	25		1 260
	1 575						,	3 2	4	3	6	5	8	7	11	9	12	11	15	14	17	17	20	22	25	25	29		1 575
	1890						1 :	3 3	5	4	6	7	9	10	12	12	14	14	17	18	20	21	23	27	29	31	33		1 890
	2 205						2	3 4	5	6	7	9	10	13	14	14	15	18	19	21	22	25	26	32	33	37	38		2 205
		0.010	0.015	X	0.025	0.040	0.065		0-10	0.	15	0.	25	\setminus	<	0.	40	\geq	\leq	0.0	55	\geq	\leq	1.	0	\geq	\leq	>1.0	
						ACCE	PTABL	Ε (QUALI	TY	E۷	EL	S (T	IGH	TEN	ED	INSF	PECT	ION)									

A = Use next preceding sample size code letter for which acceptance and rejection numbers are available.

Ac = Acceptance number

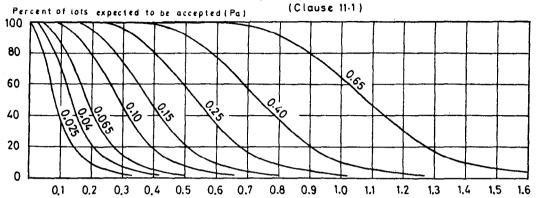
Re = Rejection number.

* = Use single sampling plan above,

= Acceptance not permitted at this sample size.

TABLE 10R TABLES FOR SAMPLE SIZE CODE LETTER R

CHART R- Operating characteristic curves for single sampling plans (curves for double and multiple sampling are matched as closely as practicable)



Quality of submitted lots (p in percent defective for AQLs \$\leq 10; in defects per hundred units for AQLs \$\rightarrow 10\right) NOTE - Figures on curves are Acceptable Quality Levels (AQLs) for normal inspection.

TABLE 10 R-1 TABULATED VALUES FOR OPERATING CHARACTERISTIC CURVES FOR SINGLE SAMPLING PLANS
(Clause 11.1)

				(Clause	11.17					
			ACCEPTA	BLE QUALI	Y LEVELS!	NORMAL IN	SPECTIÓN)			
0.025	0 040	0.065	0.10	0.15	$\supset <$	0.25		0.40	\triangleright	0.65
			p(in Perc	ent Defectiv	e or Defect	s per Hundre	ed Units I	,		
0.0074	0.0218	0.0412	0.0892	0,145	0.175	0.239	0.305	0.374	0.517	0.629
0.0178	0.0409	0.0683	0.131	0.199	0.235	0.309	0.385	0.462	0.622	0.745
0.0266	0.0551	0.0873	0.158	0.233	0,272	0.351	0.432	0.515	0.684	0.812
0.0481	0.0868	0.127	0,211	0.298	0.342	0.431	0.521	0.612	0.795	0.934
0.0839	0.134	0.184	0.284	0.384	0,433	0.533	0.633	0.733	0.933	1.08
0.135	0.196	0.256	0.371	0.484	0.540	0.651	0.761	0.870	1.09	1.25
0.195	0.266	0.334	0.464	0.589	0.650	0.770	0.889	1.01	1.24	1.41
0.237	0.315	0.388	0.526	0:657	0.722	0.848	0.972	1.09	1.33	1.51
0.332	0.420	0.502	0.655	0.800	0.870	1.02	1,14	1.27	1.53	1.72
0.040	0.065	0.10	0.15		0.25		0.40		0.65	
	<u> </u>	·	Acceptabl	e Quality Le	vets (Tighter	ned Inspectio	n)		<u> </u>	
	0.0074 0.0178 0.0266 0.0481 0.0839 0.135 0.195 0.237	0.0074 0.0218 0.0178 0.0409 0.0266 0.0551 0.0481 0.0868 0.0839 0.134 0.135 0.196 0.195 0.266 0.237 0.315 0.332 0.420	0.0074 0.0218 0.0412 0.0178 0.0409 0.0683 0.0266 0.0551 0.0873 0.0481 0.0868 0.127 0.0839 0.134 0.184 0.135 0.196 0.256 0.195 0.266 0.334 0.237 0.315 0.388 0.332 0.420 0.502	0.025 0.040 0.065 0.10 p (in Percentage) 0.0074 0.0218 0.0412 0.0892 0.0178 0.0409 0.0683 0.131 0.0266 0.0551 0.0873 0.158 0.0481 0.0868 0.127 0.211 0.0839 0.134 0.184 0.284 0.135 0.196 0.256 0.371 0.195 0.266 0.334 0.464 0.237 0.315 0.388 0.526 0.332 0.420 0.502 0.655 0.040 0.065 0.10 0.15	ACCEPTABLE QUALIT 0.025	0.025 0.040 0.065 0.10 0.15 P (in Percent Defective or Defect 0.0074 0.0218 0.0412 0.0892 0.145 0.175 0.0178 0.0409 0.0683 0.131 0.199 0.235 0.0266 0.0551 0.0873 0.158 0.233 0.272 0.0481 0.0868 0.127 0.211 0.298 0.342 0.0839 0.134 0.184 0.284 0.384 0.433 0.135 0.196 0.256 0.371 0.484 0.540 0.195 0.266 0.334 0.464 0.589 0.650 0.237 0.315 0.388 0.526 0.657 0.722 0.332 0.420 0.502 0.655 0.800 0.870 0.040 0.065 0.10 0.15 0.25	ACCEPTABLE QUALITY LEVELS (NORMAL IN: 0.025	ACCEPTABLE QUALITY LEVELS (NORMAL INSPECTION) 0.025	ACCEPTABLE QUALITY LEVELS (NORMAL INSPECTION) 0.025	ACCEPTABLE QUALITY LEVELS (NORMAL INSPECTION) 0.025

NOTE - All values given in above table based on Poisson distribution as an approximation to the Binomial.

 Δ = Use next preceding sample size code letter for which acceptance and rejection numbers are available.

Ac = Acceptance number

Re = Rejection number

* = Use single sampling plan above

= Acceptance not permitted at this sample size.

TABLE 10 S FOR SAMPLE SIZE CODE LETTER S (Clause 11-1)

	(Clause	11-1 /	
TYPE OF Sampling Plan	CUMULA- TIVE SAMPLE SIZE	ACCEPTABLE LEVELS (No. Inspection)	Mal.ITY
		Ac	Re
SIMPLE SINGLE	3 150	1	2
DOUBLE	2 000	0	2
	4 000	1	- ż
	800	#	2
	1 600	#	2
	2 400	0	2
	3 200	0	3
MULTIPLE	4 000	1	3
	4 800	1	3
	5 600	2	3
		0.025	
•		ACCEPTABLE LEVELS (Tight Inspection	ened

Ac = Acceptance number

Re = Rejection number

= Acceptance not permitted at this sample size

APPENDIX A

(Clause 0.5)

INDEX OF TERMS WITH SPECIAL MEANINGS

Acceptable quality level (AQL) 4.2 and 11.1

Acceptance number 9.4 and 10.1.1

Attributes 3.2

Average outgoing quality (AOQ) 11.3

Average outgoing quality limit (AOQL) 11.4

Average sample size 11.5

Batch 5.1

Classification of defects 3.4.1

Code letters 9.3

Critical defect 3.4.1.1

Critical defective 3.4.2.1

Defect 3.4.1

Defective unit 3.4.2

Defects per hundred units 3.5.3

Double sampling plan 10.1.2

Inspection 3.1

Inspection by attributes 3.2

Inspection level 9.2

Inspection lot or inspection batch 5.1

Insolated lot 11.6

Limiting quality (LQ) 11.6

Lot 5.1

Lot or batch size 5.3

Major defect 3.4.1.2

Major defective 3.4.2.2

Minor defect 3.4.1.3

Minor defective 3.4.2.3

Multiple sampling plan 10.1.3

Normal inspection 8.1 and 8.2

Operating characteristic curve 11.1

Original inspection 11.2

Percent defective 3.5.2

Preferred AQLs 4.6

Process average 11.2

Reduced inspection 8.2, 8.3.3 and 10.1.4

Rejection number 10.1.1

Responsible authority 1.1

Resubmitted lots or batches 6.4

Sample 7.1

Sample size 7.1

Sample size code letter 4.1 and 9.3

Sampling plan 9.5

Single sampling plan 10.1.1

Small-sample inspection 9.2

Switching procedures 8.3

Tightened inspection 8.2 and 8.3.1

Unit of product 3.3

INDIAN STANDARDS

ON

RELIABILITY OF ELECTRONIC AND ELECTRICAL COMPONENTS AND EQUIPMENT

IS:

```
1885 (Part XXXIX)-1979 Electrotechnical vocabulary: Part XXXIX Reliability of electronic and electrical items (first revision)
```

2612-1965 Recommendation for type approval and sampling procedures for electronic components

7354 Guide on reliability of electronic and electrical items:

(Part I)-1975 Preliminary reliability considerations

(Part II)-1975 Managerial aspects of reliability

(Part III)-1975 Presentation of reliability data on electronic and electrical components (or parts)

(Part IV)-1974 Collection of reliability, availability and maintainability data from field performance

(Part V)-1975 Inclusion of lot-by-lot and periodic inspection procedures in specifications for electronic and electrical components (or parts)

(Part IV)-1983 Inclusion of reliability clauses into specifications for components (or parts) (first revision)

7690-1975 Mathematical guide to the terms and definitions for reliability of electronic equipment and components (or parts) used therein

8161 Guide for equipment reliability testing:

(Part I)-1976 Principles and procedures

(Part V)-1981 Compliance test plans for success ratio

(Part VI)-1983 Tests for validity of a constant failure rate assumption

(Part VII)-1977 Compliance test plans for failure rate and mean time between failures assuming constant failure rate

(Part XI)-1983 Flow chart describing preparations for and execution of reliability tests

9185 Endurance (life) test for electronic and electrical components:

(Part I)-1979 Thermal endurance

(Part II)-1979 Mechanical endurance

9186-1979 Guide for screening of electronic and electrical items

9692 Guide on maintainability of equipment:

(Part I)-1980 Introduction to maintainability

(Part II)-1980 Maintainability requirements in specifications and contracts

(Part III)-1981 Maintainability programme

10139-1982 Presentation of reliability, maintainability and availability predictions